



Thesis Defense

MEASUREMENT OF THE $t\bar{t}$ PRODUCTION CROSS SECTION IN $p\bar{p}$ COLLISIONS AT $\sqrt{s} = 1.96$ TeV USING LEPTON + JETS EVENTS IN THE CDF DETECTOR AT FERMILAB

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Outline

- Introduction/Motivation
- Jet Probability Tagging Algorithm
 - ◇ Description of the algorithm
 - ◇ Efficiency
 - ◇ Mistag rate
- $t\bar{t}$ Cross Section Measurement
 - ◇ Data sample and event selection
 - ◇ Acceptance and background estimate
 - ◇ Discussion of the results
- Summary

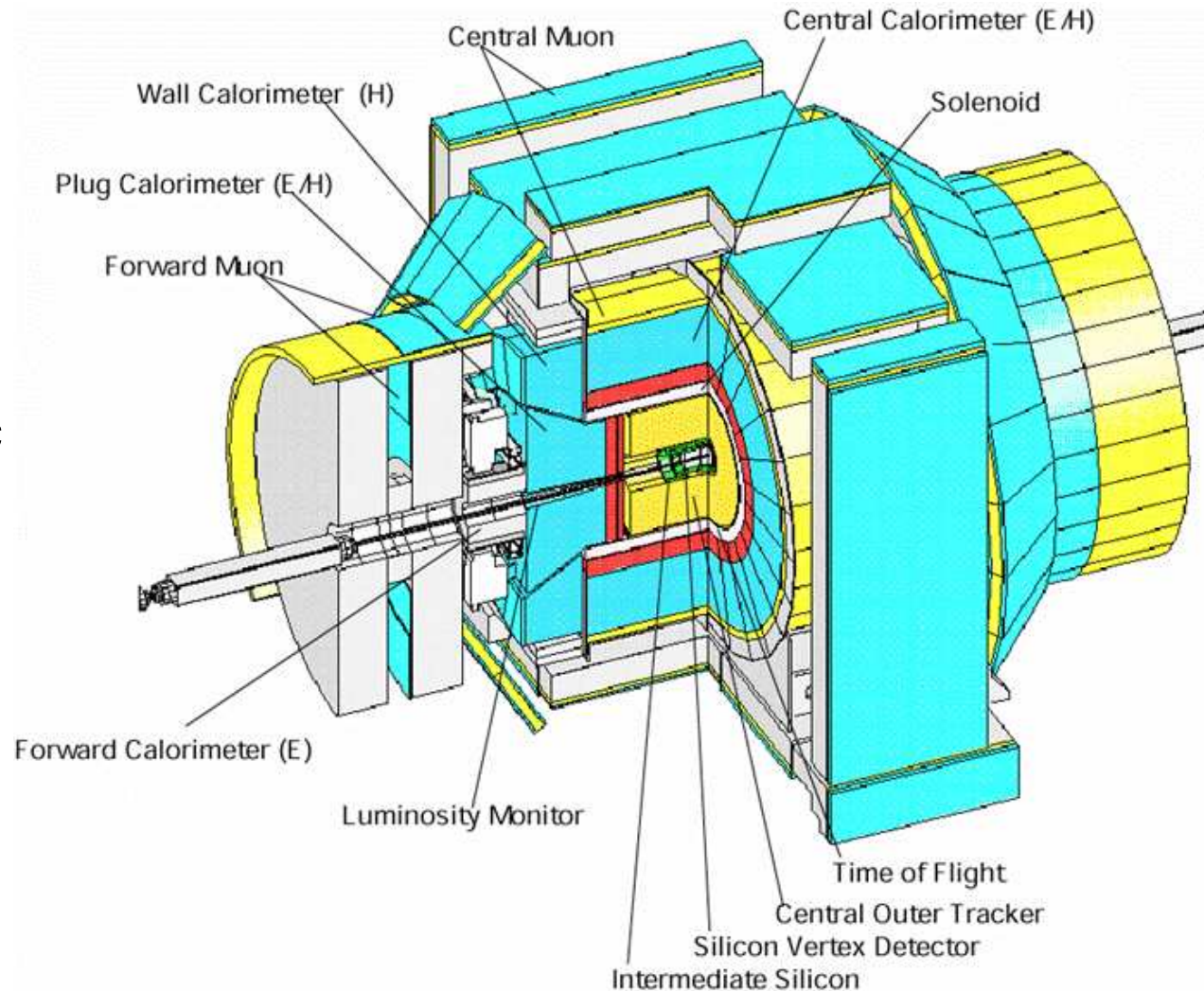
The Tevatron

- Highest energy $p\bar{p}$ collider
 - ◇ Energy of the beam = 980 GeV
 - ◇ $\sqrt{s} = 1.96 TeV$ (Run I $\rightarrow 1.8 TeV$)
- Collisions every 396 ns (Run I 3.5 μs)
- Currently, the world's only top quark production machine
- Run I: 1992 - 1996
 - ◇ Quark top discovery
- Run II: 2001 - nowadays
 - ◇ Top Mass, B_s mixing, single top evidence



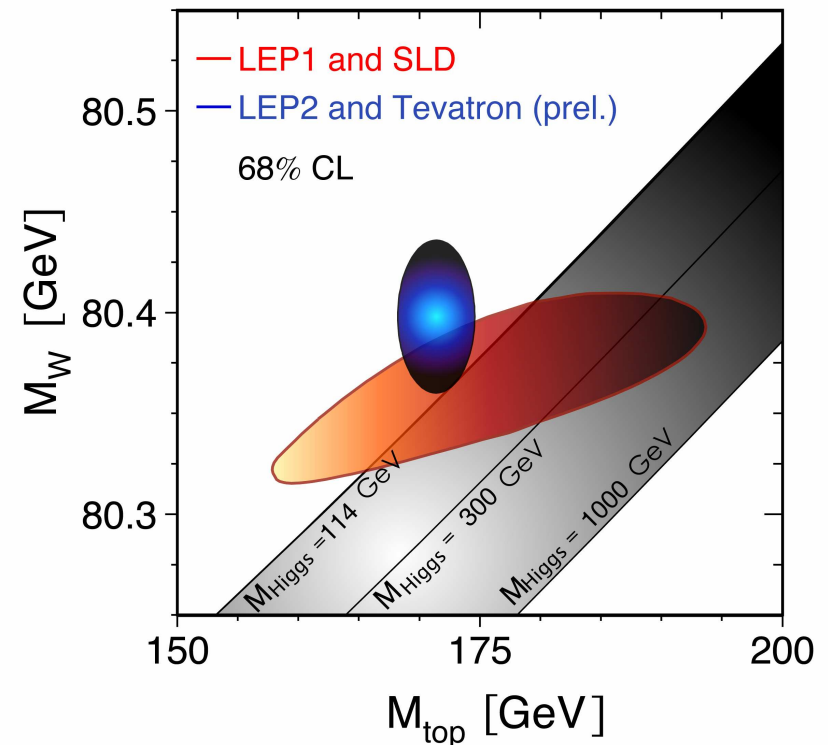
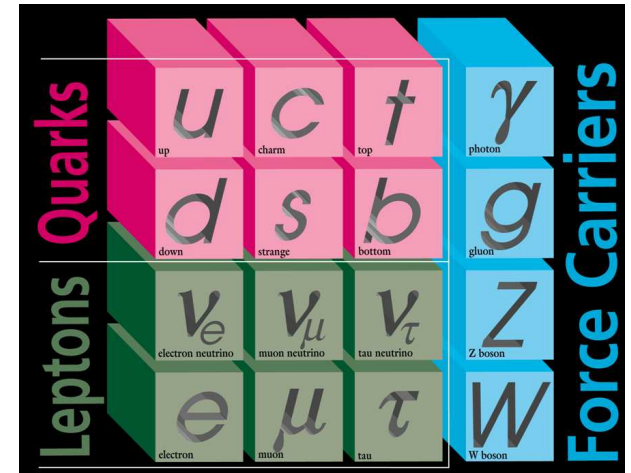
The CDF Detector

- General purpose particle detector. Cylindrical symmetry
- 3 subsystems: tracking (inside a 1.4 T solenoidal magnetic field), calorimetry and muons systems
- For top physics, the full detector is needed



Why is the Top Quark so Interesting?

- **Heaviest** known fundamental particle \Rightarrow probe physics at much higher energy scale
- **Decays before it can hadronize** ($\tau_{top} \sim 10^{-25}$ sec) \Rightarrow momentum and spin pass to the decay products
- Top quark properties **test SM**
- Look for new physics
 - ◇ Higher x-sec than predicted could be a sign of non SM production mechanisms
- Top mass **fundamental parameter** in SM
 - ◇ M_t , along with the mass of the W , is related with the mass of the SM Higgs boson



Top Production & Decay Modes

- At Tevatron energies ($\sqrt{s} = 1.96 \text{ TeV}$) top quark is mainly produced in **pairs** via strong interaction

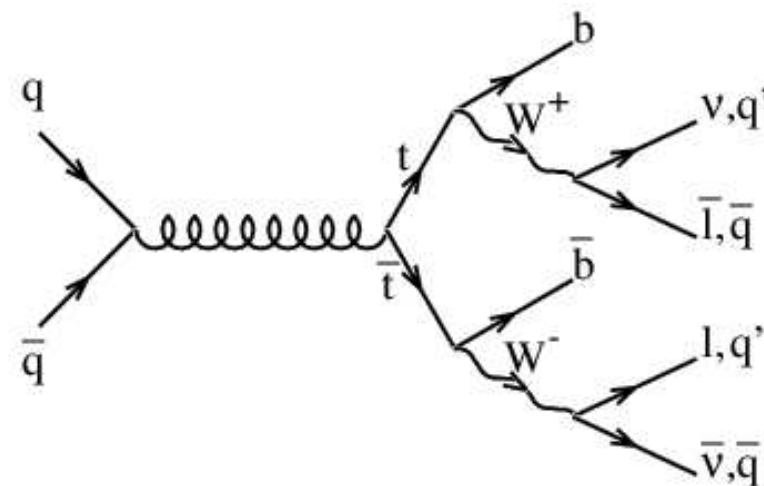
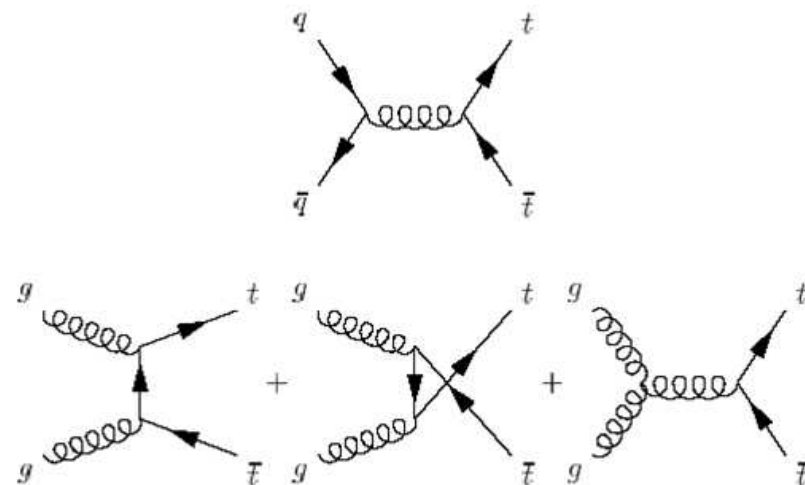
- ◇ $q\bar{q}$ annihilation (85%) or gluon fusion (15%)
- ◇ $\sigma(p\bar{p} \rightarrow t\bar{t} @ M_t = 178 \text{ GeV}) \approx 6.1 \text{ pb} \Rightarrow$ **one top event every 10 billion inelastic collisions**

- Decays via electroweak interaction $t \rightarrow Wb$

- ◇ $\text{BR}(t \rightarrow Wb) \approx 1 \Rightarrow$ final state given by W^\pm decays
- ◇ $\text{BR}(W \rightarrow \text{leptons}) = 1/3, \text{BR}(W \rightarrow \text{quarks}) = 2/3$

lepton \equiv electron or muon

Final State	Dataset	BR	S/B
$l\nu \ l\nu \ bb$	dilepton	$\sim 5\%$	4/1
$l\nu \ qq \ bb$	lepton+jets	$\sim 30\%$	2/1
$qq \ qq \ bb$	hadronic	$\sim 44\%$	1/4



Detecting the Top Quark

- Top events:

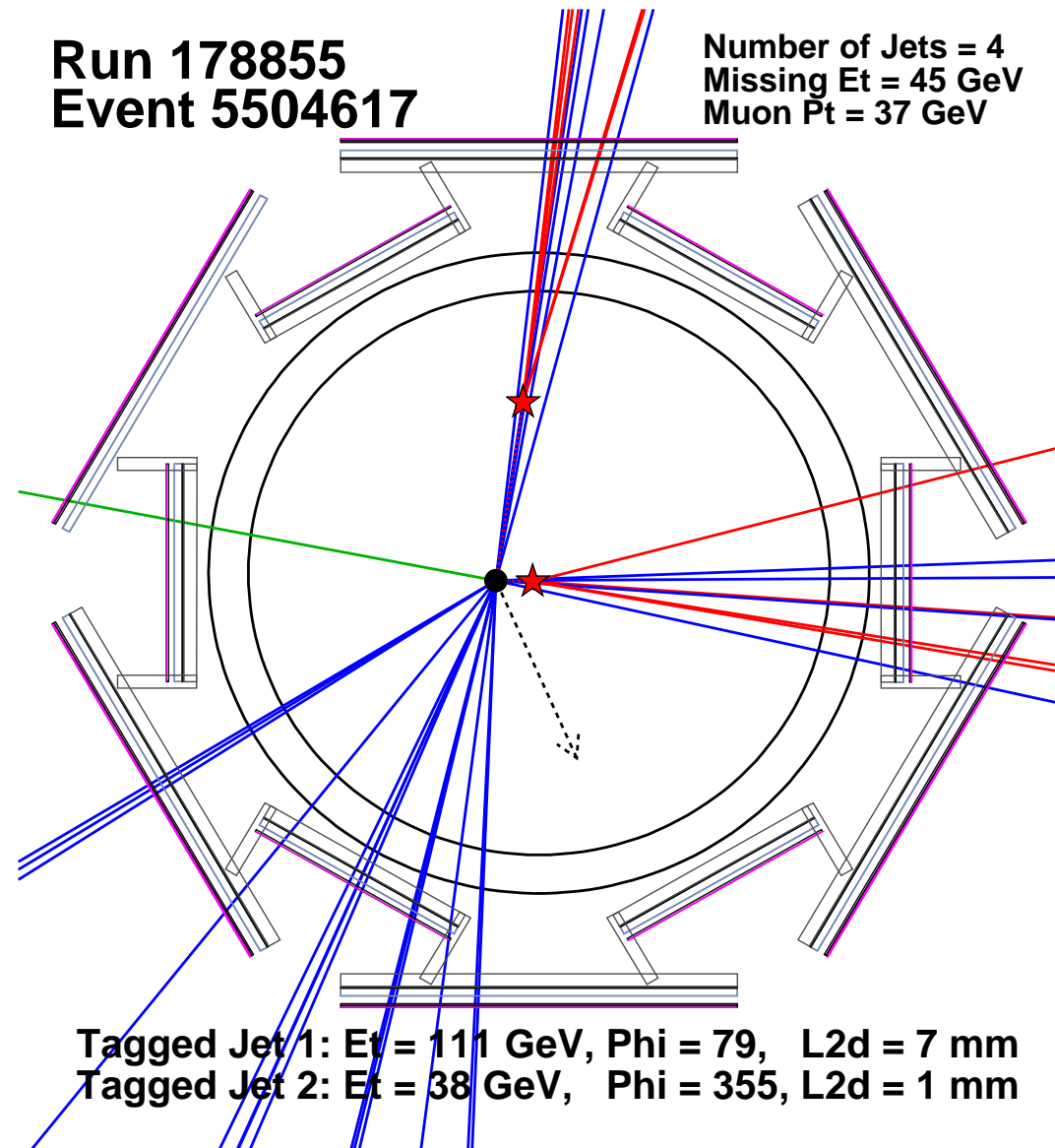
- ◇ are energetic, central and spherical
- ◇ have \cancel{E}_T from neutrinos in leptonic modes
- ◇ have jets with high E_T
- ◇ have **two high E_T b-jets**

- Main backgrounds:

- ◇ Dilepton: $Z \rightarrow l^- l^+$
- ◇ L+jets: $W + jets$ (few % have b or c)

- Identifying b-jets improves S/B

- ◇ Secondary Vertex Tagger
- ◇ Jet Probability Tagger
- ◇ Soft Lepton Tagger



B-Tagging at CDF

- B decay signature has a displaced vertex (long lifetime) travels $\Rightarrow L_{XY} \sim 3$ mm before decaying

- **Secondary Vertex Tagger**

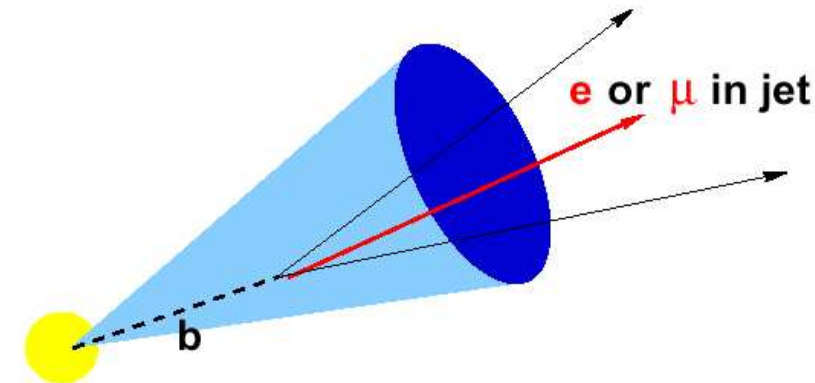
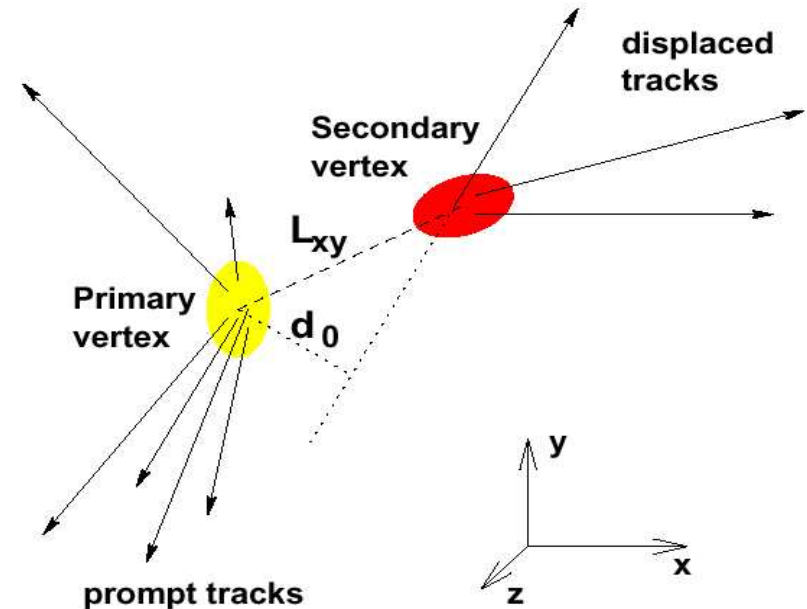
- ◊ Fit displaced tracks to a common vertex and cut on L_{XY} significance
- ◊ Relies heavily on excellent performance and understanding of the silicon tracker

- **Jet Probability Tagger**

- ◊ Joint probability for all tracks in a jet to come from a primary vertex

- **Soft Lepton Tagger**: looks for an energetic lepton inside a jet

- ◊ B can decay semileptonically: $b \rightarrow l \nu c$



- $b \rightarrow l \nu c$ (BR $\sim 20\%$)
- $b \rightarrow c \rightarrow l \nu s$ (BR $\sim 20\%$)

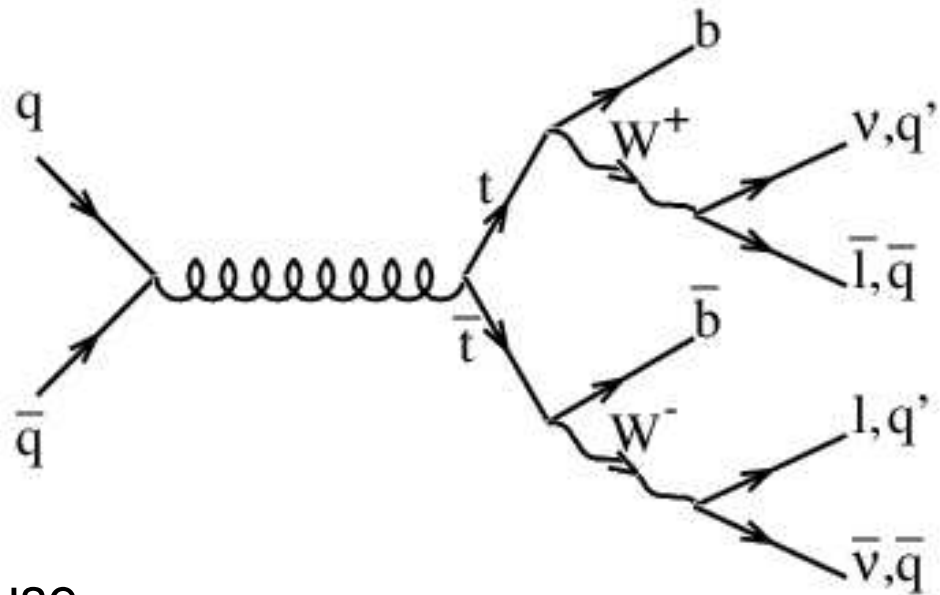
Jet Probability

- ... heavy flavor (HF) tagging?

- ◇ Top signal has 2 b's

- ◇ $\sim 5\%$ of the main backgrounds has HF

⇒ S/B greatly increased



- Jet Probability is characterized because...

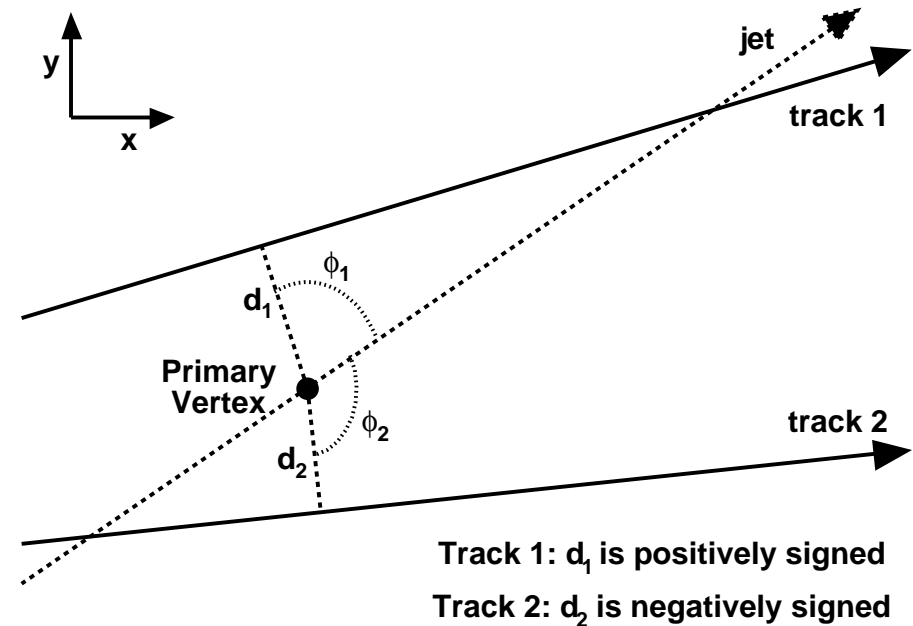
- ◇ Provides a **continuous variable** \Rightarrow more flexible way to understand the composition of the tagged sample

- ◇ Can be **tuned/optimized differently** for other kind of analyses

- ◇ This method can be used to separate b and c heavy flavor contributions

Jet Probability Algorithm (I)

- **Signed impact parameter:** $d_0 > 0$ if point of closest approach to the primary vertex lies in the same direction as the jet direction ($\cos \phi > 0$)



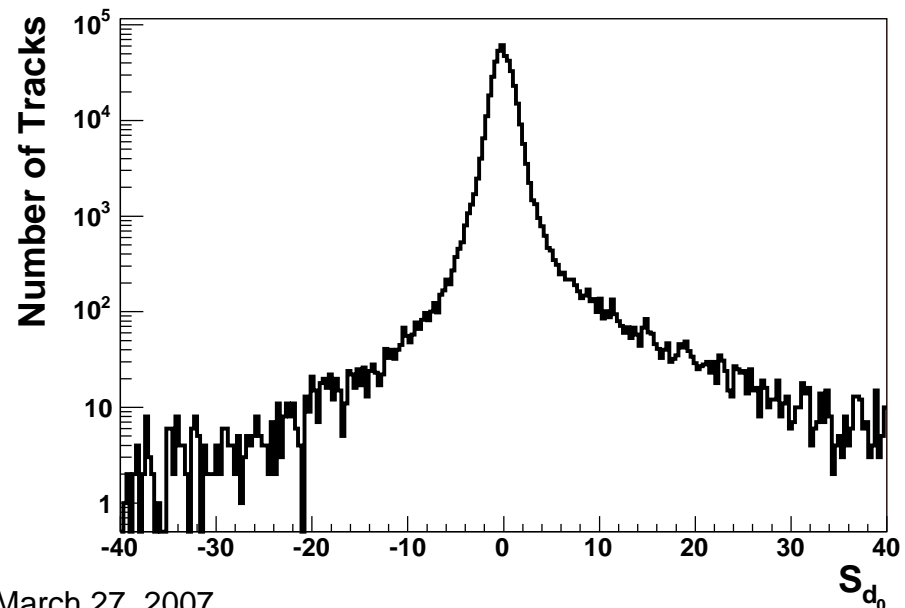
- **+ (-) Jet Probability:** only tracks with positive (negative) impact parameter

◇ + Jet Probability \Rightarrow positive tags

◇ - Jet Probability \Rightarrow mistags prediction

- Track impact parameter significance:

$$S_{d_0} = d_0 / \sigma_{d_0}$$



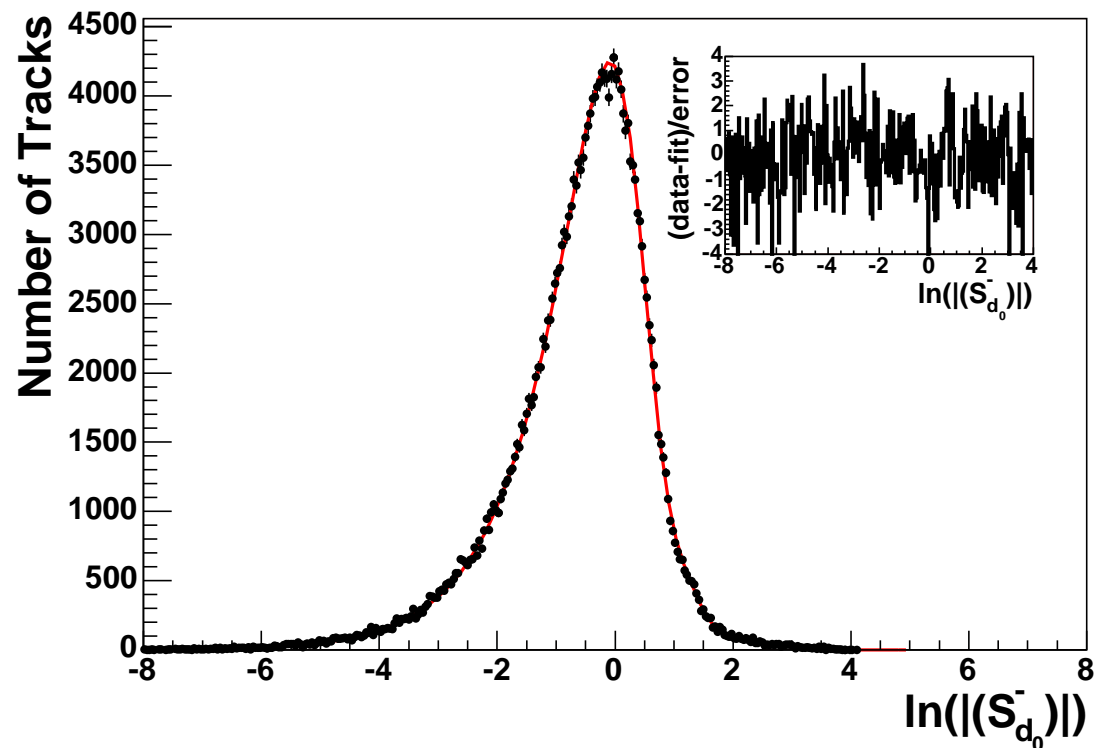
Jet Probability Algorithm (II)

- Fit the **negative side** of the track impact parameter significance distribution (only **detector resolution effects**) to obtain a resolution function $R(S)$ (different for data and MC)
- $R(S)$ used to determine the probability ($P_{tr}(S_{d_0})$) that the impact parameter significance of a given track is due to the detector resolution

$$P_{tr}(S_{d_0}) = \frac{\int_{-\infty}^{-|S_{d_0}|} R(S) dS}{\int_{-\infty}^0 R(S) dS}$$

- Probability that a jet is consistent with a zero lifetime hypothesis:

$$P_J = \prod_{l=1}^{N_{tr}} P_{tr} \times \sum_{k=0}^{N_{tr}-1} \frac{(-\ln \prod_{l=1}^{N_{tr}} P_{tr})^k}{k!}$$



Deduction of the Jet Probability Formula

- If we have a jet with 2 tracks with positive impact parameter which probabilities are P_1 and P_2 and $K \equiv P_1 \cdot P_2$

$$0 \leq P_i \leq 1 \quad i=1,2 \implies 0 \leq K \leq 1$$

- The area **below** and **in the left** of the curve of constant probability K is the set of combinations, for the 2 tracks, of having a probability less or equal than K . And this area is defined as Jet Probability, P_J

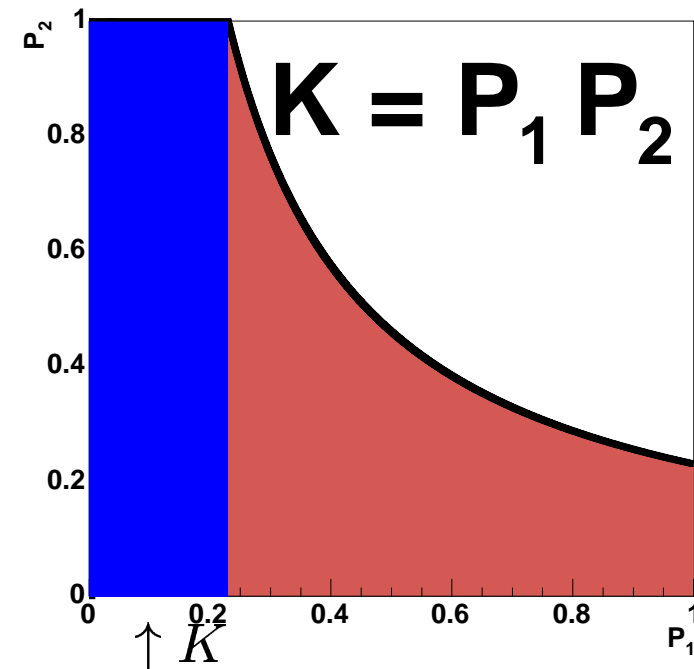
$$\diamond P_J = A + B, \quad A = K \cdot 1$$

$$\diamond B = \int_{x=K}^{x=1} f(x) dx = \int_{x=K}^{x=1} \frac{K}{x} dx = -K \ln K$$

$$\implies P_J = K(1 - \ln K)$$

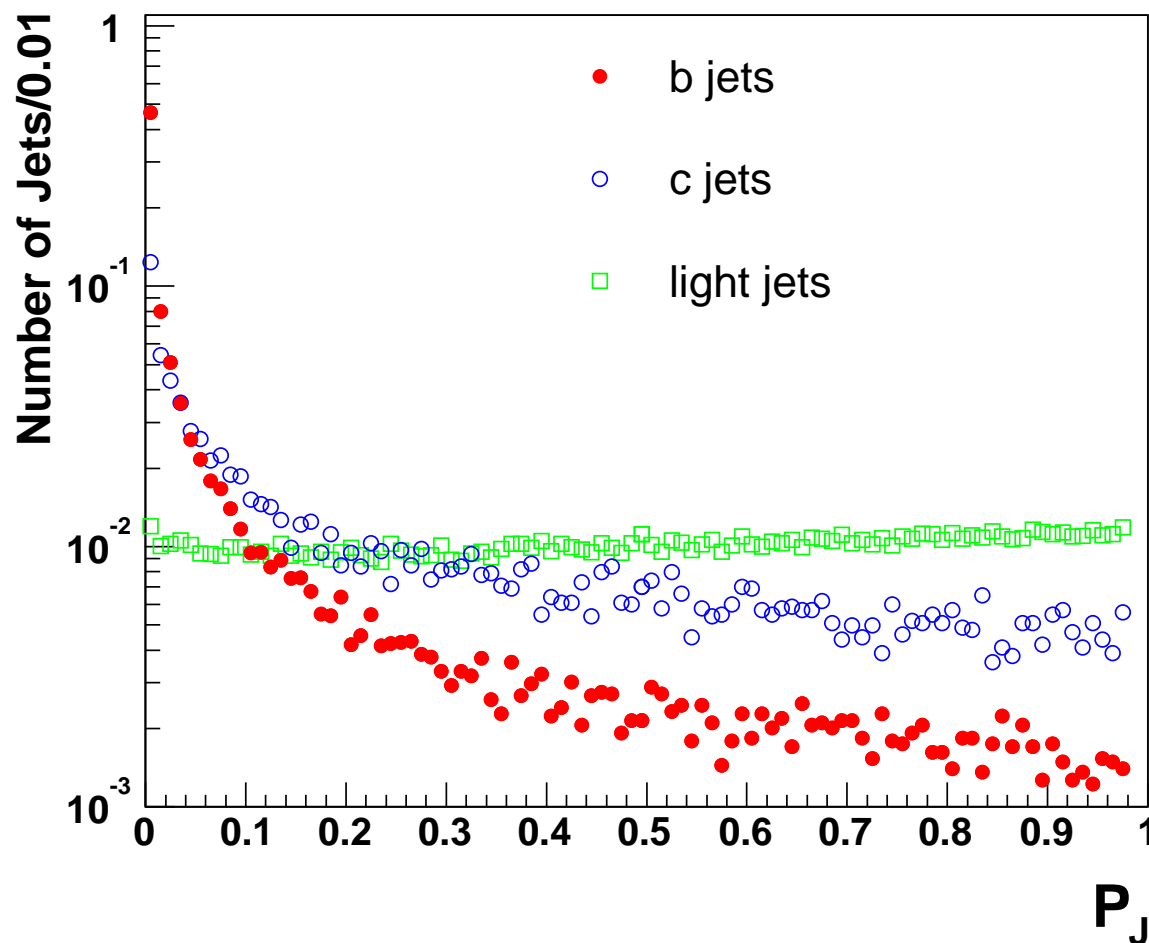
- In general, it can be shown that

$$P_J = \prod_{l=1}^{N_{tr}} P_{tr} \times \sum_{r=0}^{N_{tr}-1} \frac{(-\ln \prod_{l=1}^{N_{tr}} P_{tr})^r}{r!}$$



Jet Probability Algorithm (III)

- HF hadrons have long lifetime \Rightarrow displaced vertices (and tracks) from the primary vertex
- Physically, probability for a jet to come from the primary vertex
- Uniform for light quark or gluon jets. Peaks at 0 for jets containing displaced tracks from HF decays
- For the analysis, $P_J < 1\%$ and $P_J < 5\%$



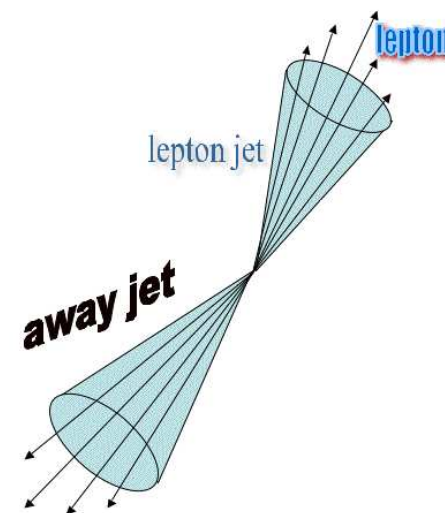
Jet Probability Efficiency (I)

- Measured using an 8 GeV **inclusive electron data sample** (it is enriched with HF due to the semileptonic B decays)

- **Single tag method:** $\epsilon = \frac{N_{ej}^+}{N_{ej}} \rightarrow \epsilon = \frac{N_{ej}^+ - N_{ej}^-}{N_{ej}} \rightarrow \epsilon = \frac{N_{ej}^+ - N_{ej}^-}{N_{ej}} \cdot \frac{1}{F_{HF}}$

◇ Disadvantage: relies on the correct determination of the heavy flavor fraction in the sample

- **Double tag method:** as heavy flavor quarks are mostly produced in pairs, heavy flavor content in one jet is enhanced requiring that the “other” jet (away jet) is tagged



Jet Probability Efficiency (II)

- If there were no light jets mistagged as b-jets: $\epsilon = \frac{N_{a+}^{e+}}{N_{a+}} \cdot \frac{1}{F_{HF}^a}$

- But this is not true so:

$$\epsilon = \frac{(N_{a+}^{e+} - N_{a+}^{e-}) - (N_{a-}^{e+} - N_{a-}^{e-})}{N_{a+} - N_{a-}} \cdot \frac{1}{F_{HF}^a}$$

- ◇ F_{HF}^a is the fraction of HF e-jets for which the away jet is tagged

$$F_{HF}^a = 1 - P(1 - F_{HF})$$

- ◇ P is the probability to positively tag the away jet in an event where the e-jet is a light jet

- ◇ F_{HF} is the total HF fraction of e-jets

$$F_{HF} = F_b + F_c = F_b \times (1 + F_{c/b})$$

- ◇ F_b (F_c) is the total b (c) fraction of e-jets

Jet Probability Efficiency (III)

- There are 2 methods to calculate F_b

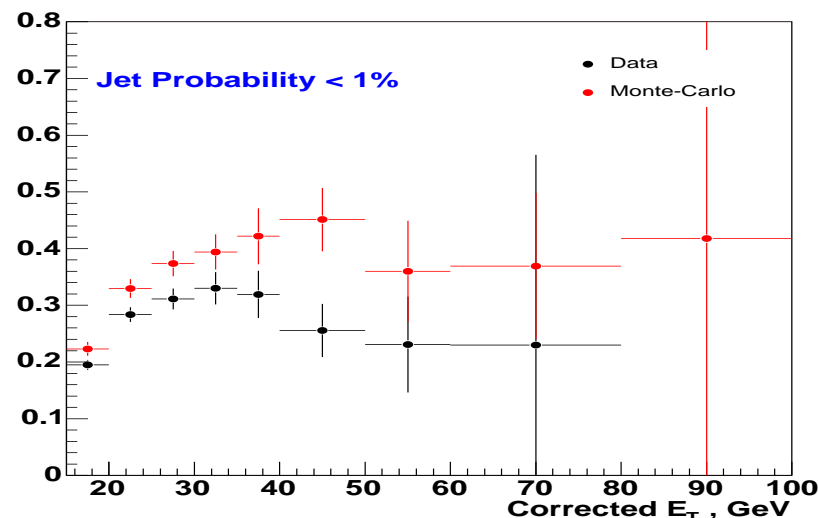
◇ Reconstruct $D^0 \rightarrow K\pi$ decays and use the invariant mass sidebands to subtract backgrounds: $F_b = \frac{N_{D^0}}{N_{ej}} \cdot \frac{1}{\epsilon_{D^0}}$

◇ From cascade muons: select b-hadrons with 2 semileptonic decays ($b \rightarrow c \rightarrow X$) emitting a pair $e\text{-}\mu$ with opposite charge: $F_b = \frac{1}{\epsilon_\mu} \frac{N_{ej}^\mu(OS) - N_{ej}^\mu(SS)}{N_{ej}}$

F_b	$F_{c/b}$	F_{HF}	F_{HF}^a
0.16 ± 0.02	0.61 ± 0.10	0.26 ± 0.06	0.71 ± 0.05

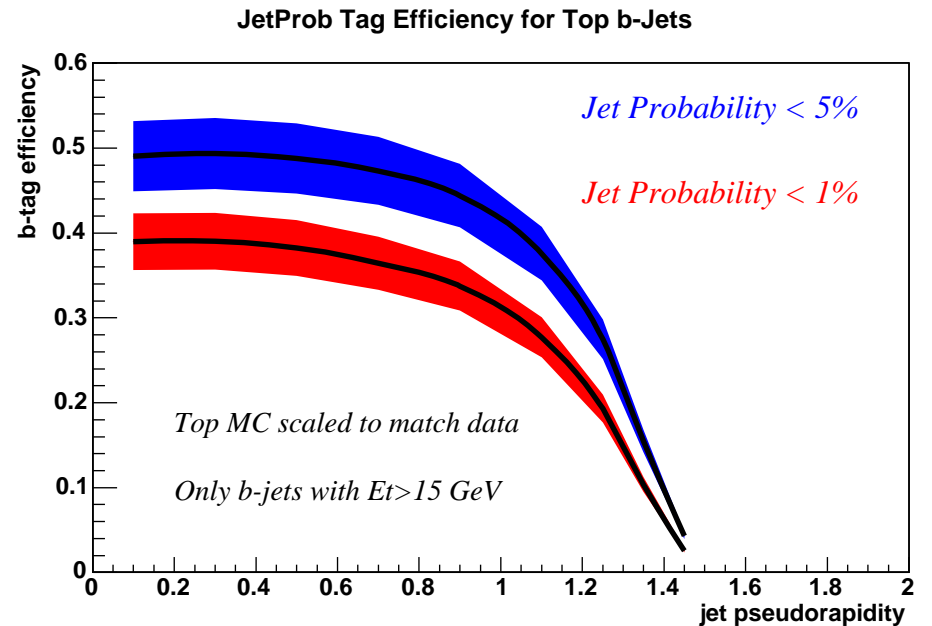
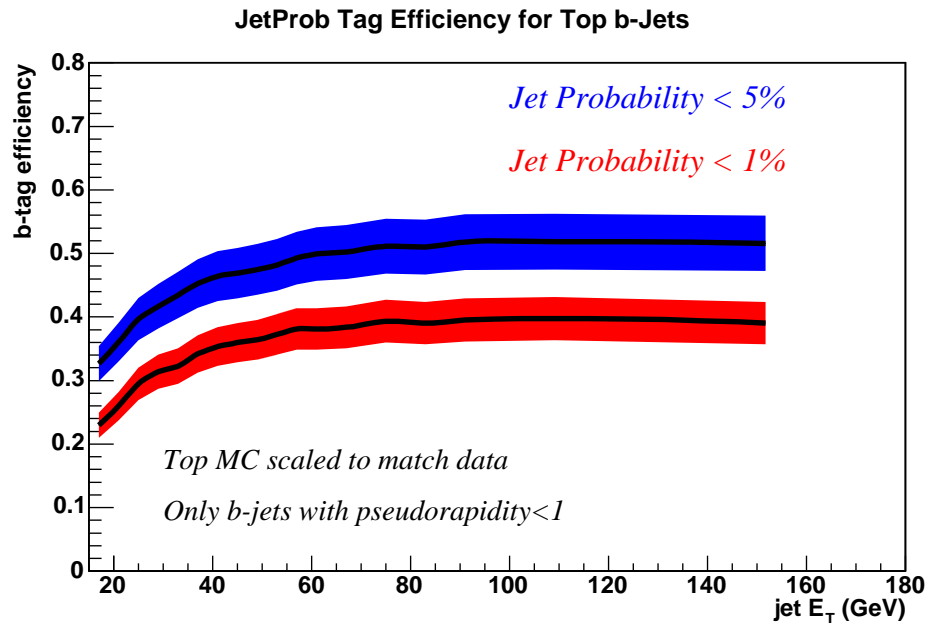
- Efficiencies to tag a heavy flavor jet with $E_T > 15$ GeV and 318 pb^{-1}

	$P_J < 1\%$	$P_J < 5\%$
ϵ^{data}	0.258 ± 0.018	0.334 ± 0.026
ϵ^{MC}	0.316 ± 0.021	0.392 ± 0.026



Jet Probability Efficiency in $t\bar{t}$ Events

- b-tagging efficiency (tag rate \times SF) per jet in a **top Monte Carlo** sample. Bands represent the systematic error due to the scale factor.



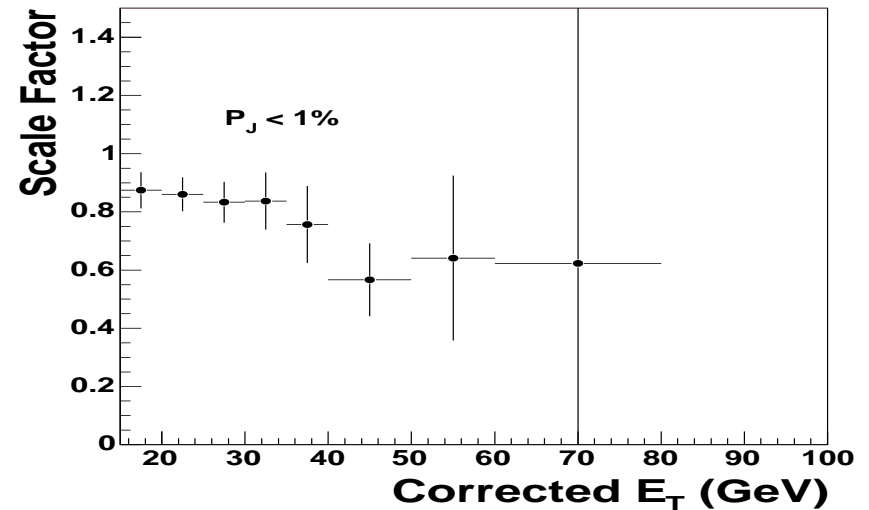
b-tagging efficiency (%)	$P_J < 1\%$	$P_J < 5\%$
per b-jet	35 ± 3	47 ± 4
per $t\bar{t}$ event	55 ± 4	69 ± 4

Scale Factor

- Scale Factor is the ratio between the data and Monte Carlo efficiencies

	$P_J < 1\%$	$P_J < 5\%$
Scale Factor (SF)	0.817 ± 0.070	0.852 ± 0.072

- Studied the SF dependence with E_T in two other samples and assume it is flat
- Large uncertainty: $\text{BR}(B \rightarrow l\nu D^0 X)$, difference between data and MC in ϵ_{D^0} ($\sim 10\%$), assumption in symmetry between negative tags and positive mistags ($\sim 7\%$)
- We assume the same SF for c-jets but increase the uncertainty in 100%



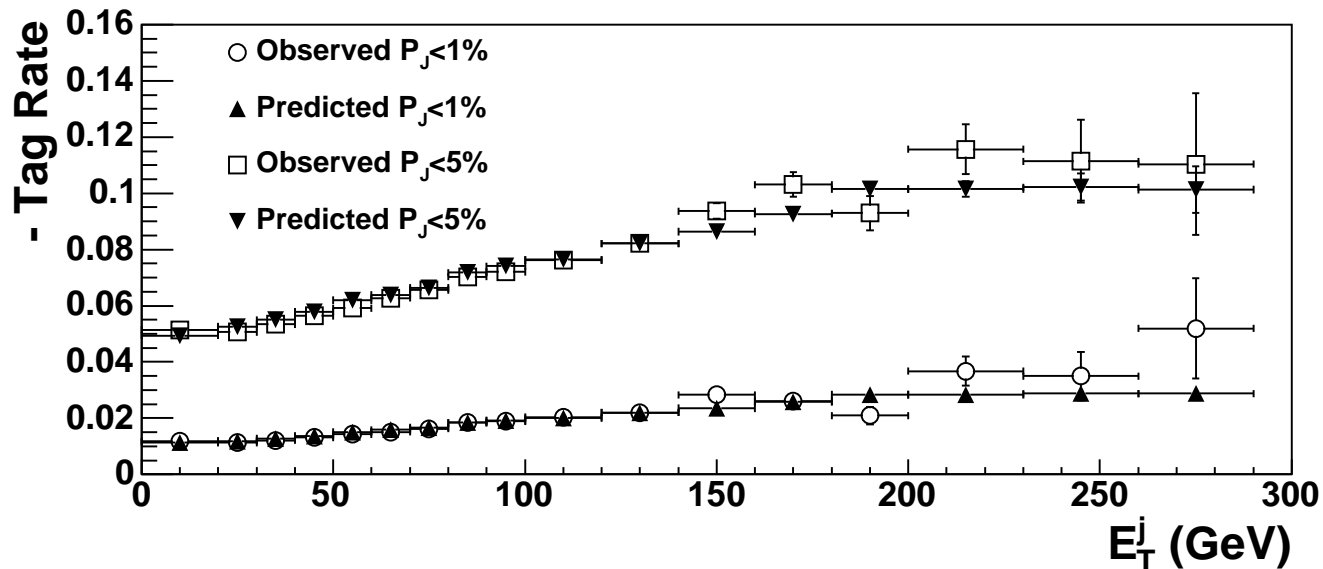
Jet Probability Mistag Rate

- Mistag rate: probability of tagging a light jet as a heavy flavor one
- Determined using 4 inclusive jet **data samples** (jet20, 50, 70 and 100)
- Parameterized as a 6 dimensional look-up table (mistag matrix): $E_T, N_{trk}, \sum E_T^j, \eta, Z_{vtx}, \phi$
 - ◇ E_T, N_{trk} and $\sum E_T^j$ to describe physics and kinematics of the jets
 - ◇ η, Z_{vtx} and ϕ to take into account detector geometry
- Positive (negative) rate = $\frac{\# \text{ jets positively (negatively) tagged}}{\# \text{ taggable jets}}$
- Results with 318 pb^{-1}

	$P_J < 1\%$	$P_J < 5\%$
Overall negative tag rate (%)	1.22 ± 0.08	5.30 ± 0.25

Jet Probability Mistag Rate: Checks

- **Consistency:** compare tag rates observed in the odd numbered events to the tag rates predicted by a matrix built only using the even numbered events
- **Predictivity:** same as above but for the tag rates as a function of variables not included in the matrix (number of vertices, run number, instantaneous luminosity)
- **Sample dependence:** compare the observed tag rates from the multijet trigger to the tag rates predicted by the tag rate matrix (inclusive jet data)



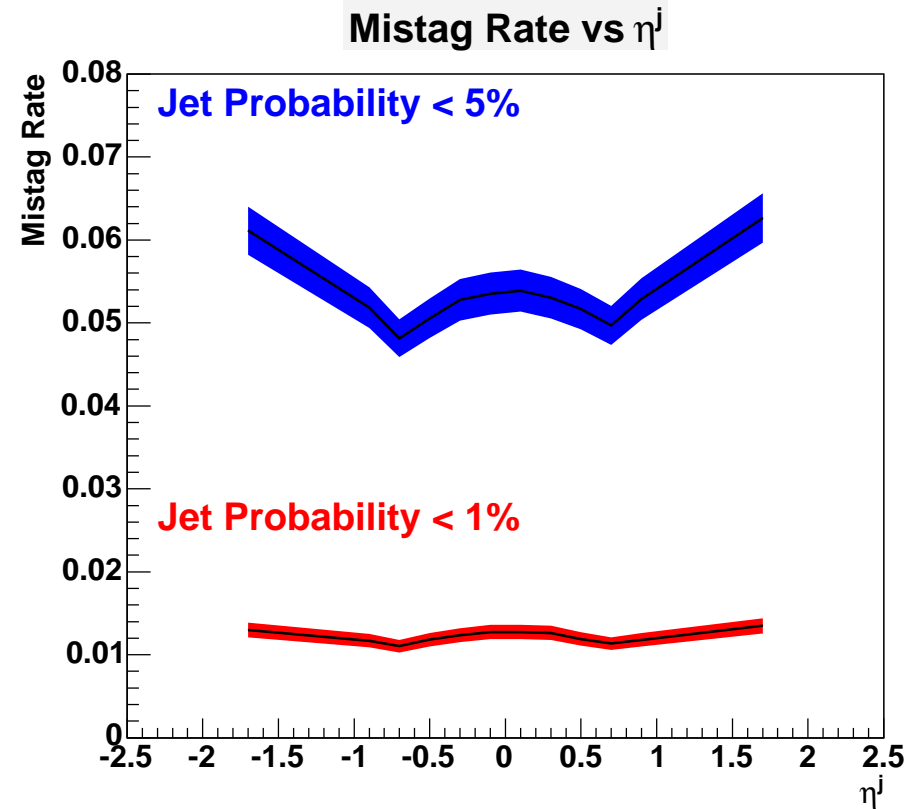
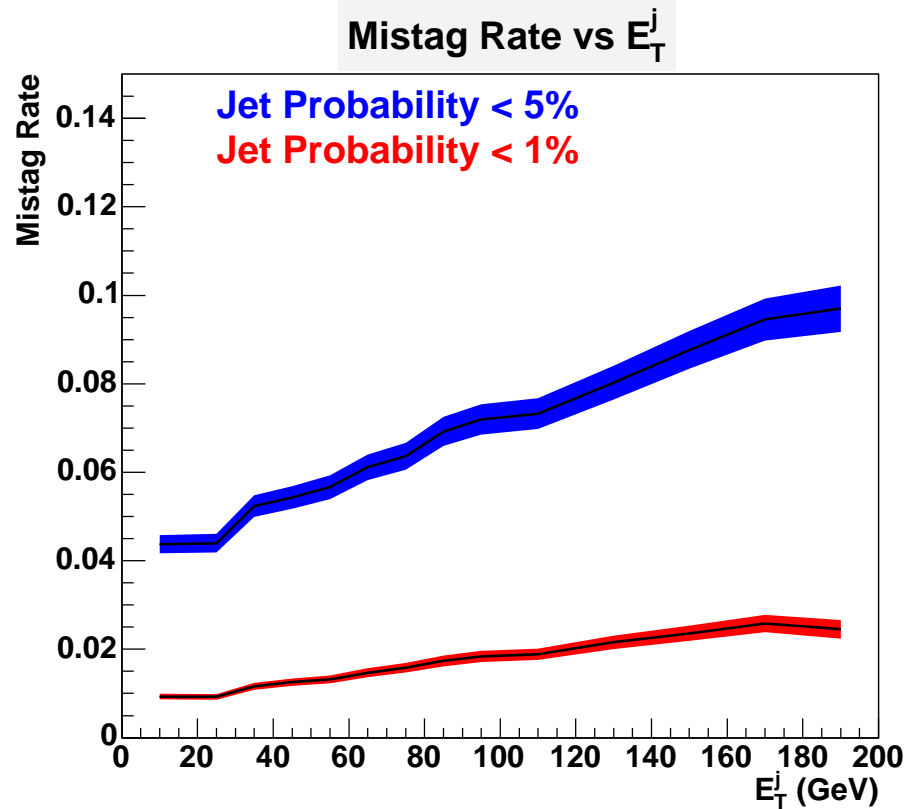
Jet Probability Mistag Rate: Systematics

- Compare the observed and predicted tag rates in different data samples
- Apply matrices built using different inclusive jet subsamples to different datasets

Matrix	Sample	Obs./Pred. Pos. Tag Rate Ratio	Obs./Pred. Neg. Tag Rate Ratio
Inc. Jet Even	Inc. Jet Odd	0.997 ± 0.002	0.999 ± 0.003
Inc. Jet Even	Jet20 Odd	0.987 ± 0.003	0.970 ± 0.006
Inc. Jet Even	Jet50 Odd	0.991 ± 0.003	0.998 ± 0.006
Inc. Jet Even	Jet70 Odd	0.997 ± 0.004	0.996 ± 0.006
Inc. Jet Even	Jet100 Odd	0.989 ± 0.003	1.029 ± 0.005
Jet20 All	Jet50 All	1.020 ± 0.003	1.044 ± 0.008
Inc. Jet Even	Trig. Jet Odd	0.976 ± 0.002	0.978 ± 0.004
Inc. Jet Even	Non trig. Jet Odd	1.028 ± 0.003	1.028 ± 0.005
Inc. Jet All	$\sum E_T^{jet}$ All	1.037 ± 0.002	0.966 ± 0.003

- Largest deviation is taken as systematic uncertainty due to the sample dependence of the matrix

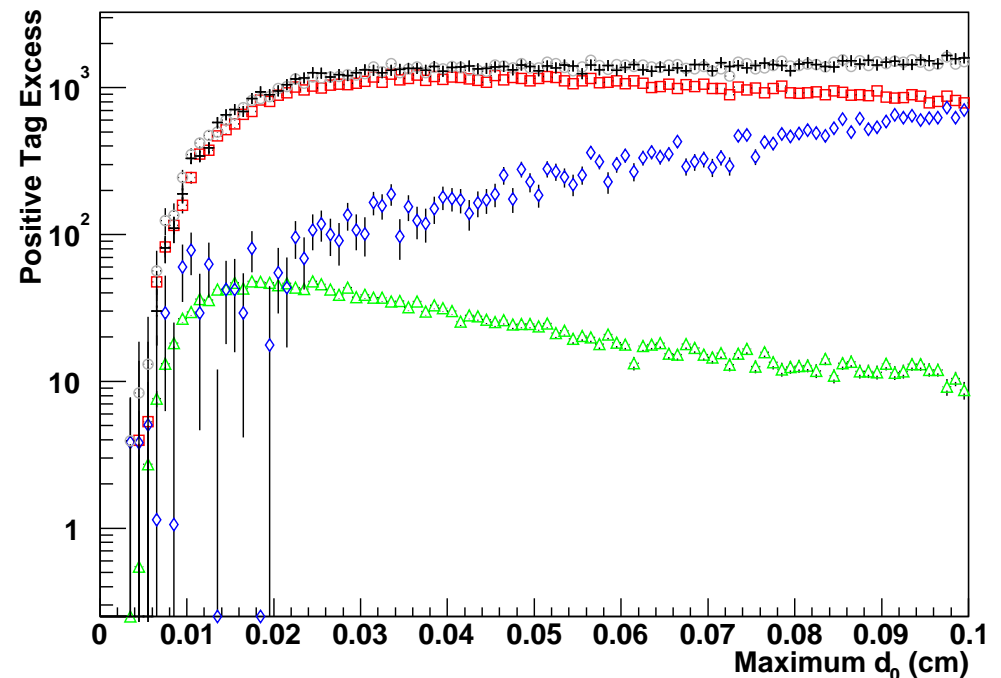
Jet Probability Mistag Rate vs E_T and η



- Bands represent the total uncertainty (statistical and systematic added in quadrature).

Jet Probability Mistag Rate: Asymmetry (I)

- Rate of negative tag jets does not completely describe the rate of positive mistags of light jets due to residual lifetime effects from Λ 's and K's or interactions with the detector \Rightarrow need to know the flavor composition of the tagged jets in data
- Fit a variable (sensitive to the flavor content of the jet: $\max(d_0)$, $\max(S_{d_0})\dots$) in data to MC templates for b, c and light jets
- Fit only positive excess (subtracting negative tags from the positive side)
- Normalize the number of negative tags from b, c and light jets in MC to the number of negative tags in data
- Extract the fractions of **b**, **c** and **light** jets in data from the fit



Jet Probability Mistag Rate: Asymmetry (II)

- Results of the fit for the six variables used

Fitted variable	$\beta (P_J < 1\%)$	$\beta (P_J < 5\%)$
Maximum d_0	1.64 ± 0.02	1.37 ± 0.02
Maximum S_{d_0}	1.56 ± 0.03	1.10 ± 0.02
Mass of the system of tracks with $ d_0 > 0.01 \text{ cm}$	1.51 ± 0.04	1.30 ± 0.02
Mass of the system of tracks with $S_{d_0} > 2$	1.43 ± 0.03	1.20 ± 0.02
$P_T^{rel.}$ of the system of tracks with $ d_0 > 0.01 \text{ cm}$	1.67 ± 0.03	1.32 ± 0.02
$P_T^{rel.}$ of the system of tracks with $S_{d_0} > 2$	1.57 ± 0.02	1.30 ± 0.02
Average	1.56 ± 0.14	1.27 ± 0.17

- For the analysis, will scale up the mistag prediction by the asymmetry factor β

Comparison with other b-Tagging Algorithms

- Efficiencies and mistag rates for the b tagging algorithms used at CDF

	$P_J < 1\%$	$P_J < 5\%$	Tight SecVtx	Loose SecVtx	SLT
Efficiency (%)	~ 55	~ 69	~ 60	~ 69	~ 15
Mistag rate (%)	~ 1.2	~ 5.3	~ 0.5	~ 1.2	~ 4

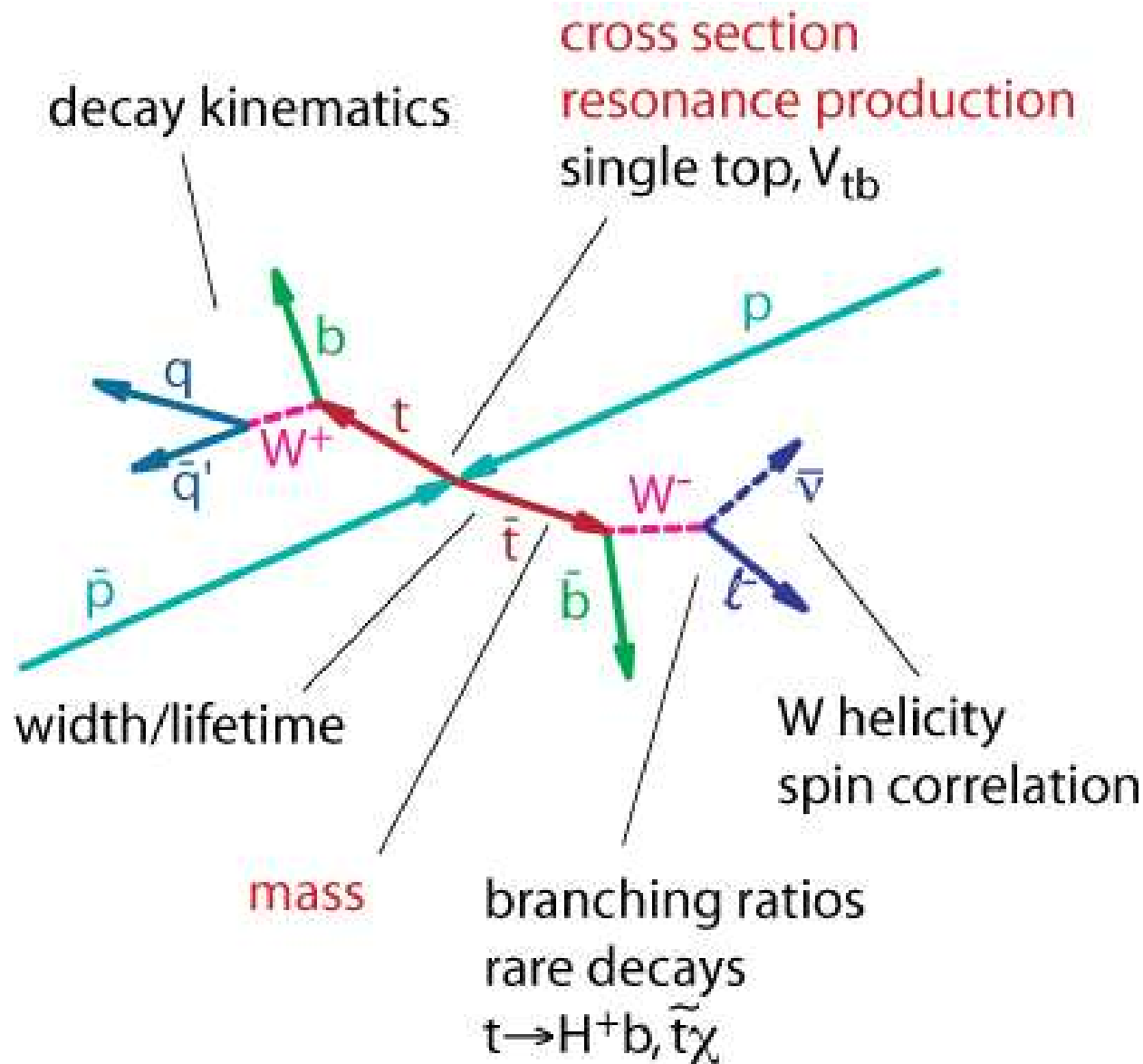
- Three different taggers that use different information

◇ Overlap Jet Probability - SecVtx $\sim 80\%$.

- Allow measure the same property using different taggers in order to reduce systematic effects

Physics analysis

TOP PHYSICS IS HUGE!!!

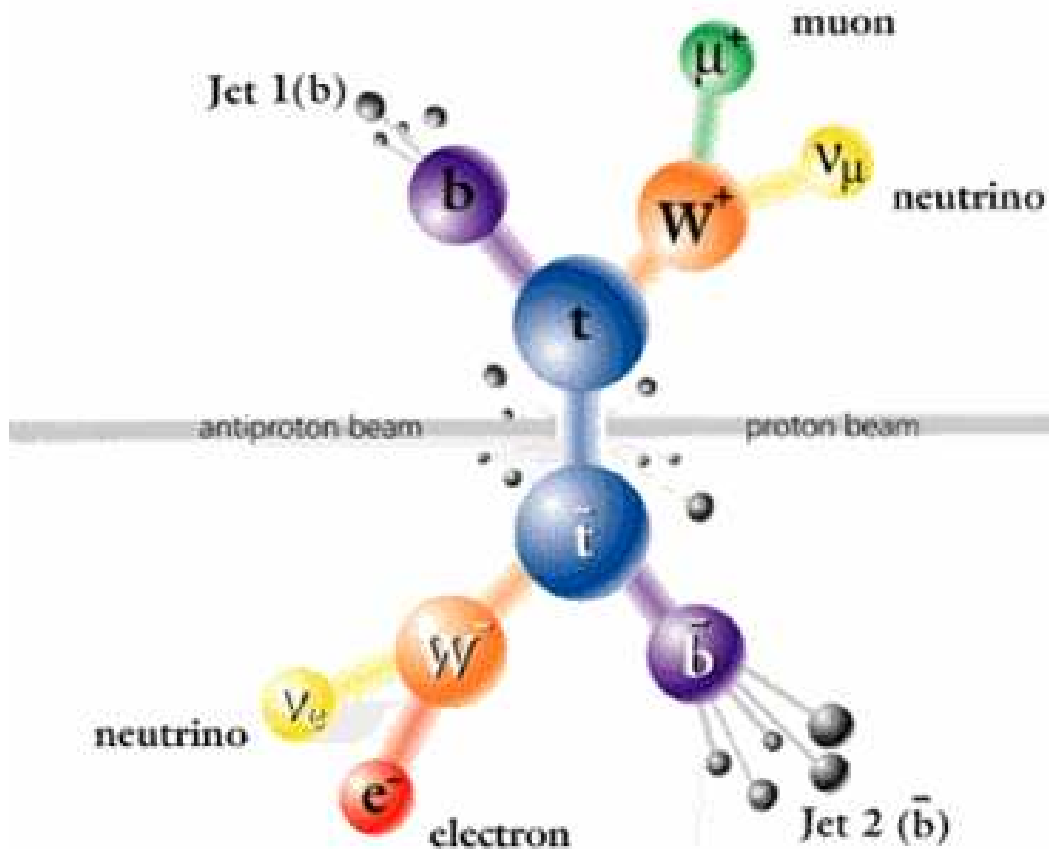


$t\bar{t}$ Cross Section Measurement

- Counting experiment:

$$\sigma_{t\bar{t}} = \frac{N_{obs} - N_{bkg}}{\epsilon_{t\bar{t}} \times \int L dt}$$

- Goal: demonstrate good understanding of the backgrounds in the control region and of the top contribution in the signal region



Data Sample

- Data sample based on Run II data taken until September 2004
- Triggers based on the selection of a lepton with high p_T

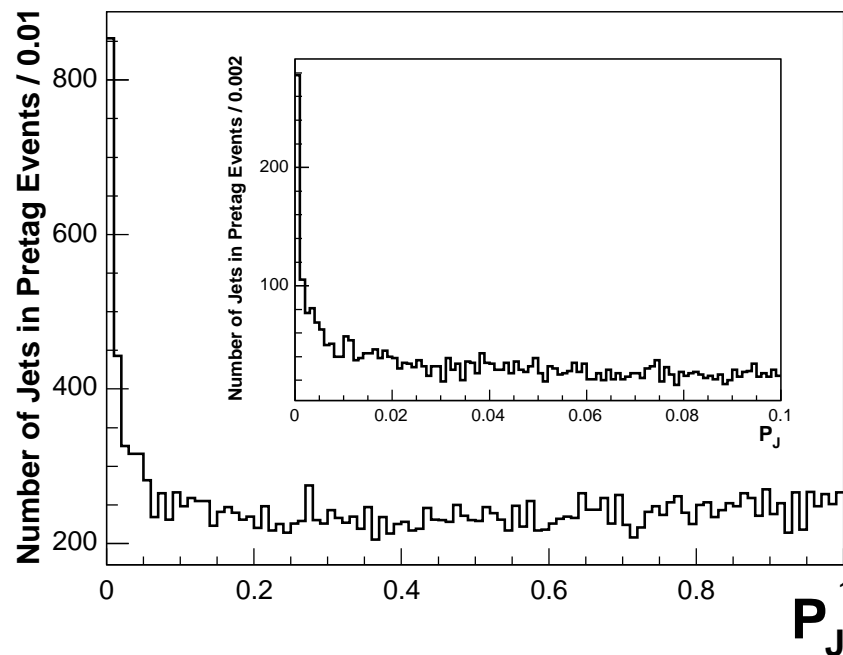
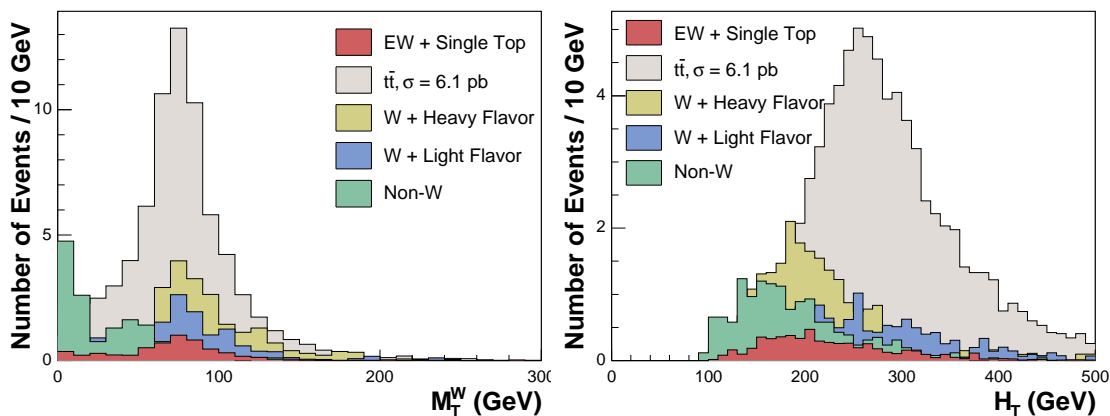
	CEM (Central electrons, $ \eta < 1$)	CMUP (Central muons, $ \eta < 0.6$)	CMX (Extension muons, $0.6 < \eta < 1$)
Lum (pb^{-1})	318.5 ± 18.8	318.5 ± 18.8	305.2 ± 18.0

- Electron identification: isolated track with $p_T > 9$ GeV that extrapolates to 3 CEM adjacent towers with $E_T > 20$ GeV
- Muon identification: isolated COT track with $p_T > 20$ GeV that extrapolates to a track segment in the muon chambers
- Jets are reconstructed from calorimeter towers using a cone algorithm with radius $R \leq 0.4$

Event Selection

- 1 high p_T isolated lepton
- High missing transverse energy
- ≥ 3 energetic jets
- Vetoes (dilepton, cosmics, conversion, z_{vtx})
- $M_T^W > 20$ GeV and $H_T > 200$ GeV

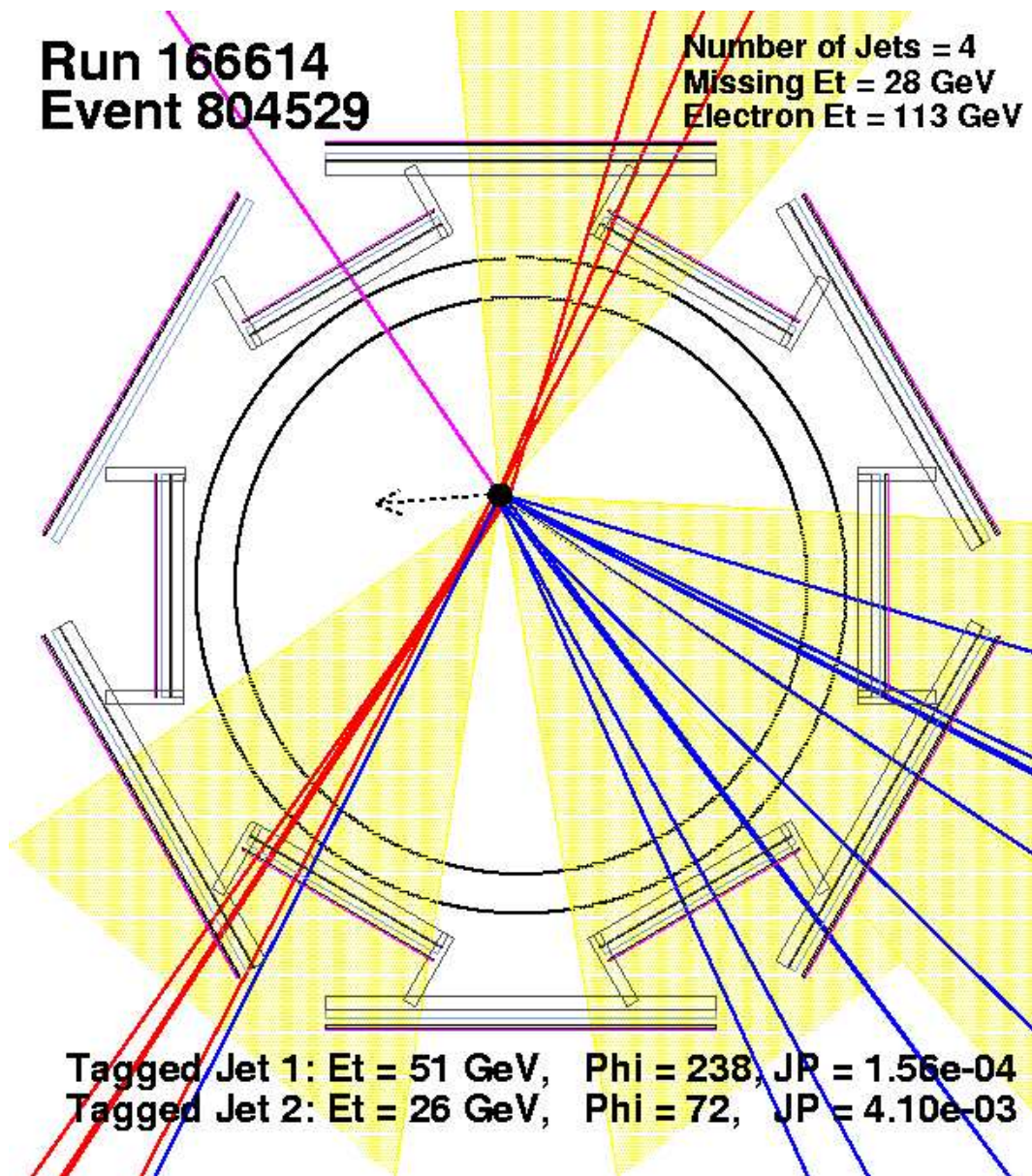
Jet Multiplicity	1 jet	2 jets	3 jets	≥ 4 jets
Before b-tagging				
# Events	29339	4442	300	166
After b-tagging ($P_J < 1\%$)				
# Events	350	191	52	68



- ≥ 1 tagged jet (jet with positive $P_J < 1\%$)

A Top Candidate Event looks like this...

- Jets are represented by yellow hashed cones
- For tagged jets, positive impact parameter tracks are drawn red
- All other (good r-phi) tracks inside jet are drawn blue
- Missing transverse energy direction is the dotted arrow
- Electron track is magenta



Acceptance (I)

$$\epsilon_{t\bar{t}} = (A_{t\bar{t}} \times K_{lep} \times \epsilon_{trig} \times \epsilon_{z_0}) \times \epsilon_{b-tag} = \epsilon_{t\bar{t}}^{pretag} \times \epsilon_{b-tag}$$

- $A_{t\bar{t}}$: fraction of MC $t\bar{t}$ events passing the kinematic requirements (including the lepton+jets branching ratio and lepton identification efficiencies)
- K_{lep} : scale factor that takes into account the difference in lepton identification efficiency between data and MC using $Z \rightarrow l^+ l^-$ events (0.996, 0.874 and 0.989)
- ϵ_{trig} : trigger efficiency for identifying high p_T leptons. Measured using data, $W^\pm \rightarrow e^\pm \nu$ and $Z \rightarrow \mu^+ \mu^-$ (0.962, 0.908 and 0.965)
- ϵ_{z_0} : efficiency of the z vertex cuts (vertex is required to be within 60 cm of the center of the detector, 0.951 from minimum bias data, and 5 cm with respect to the vertex with highest $\sum p_T$, 0.98)
- ϵ_{b-tag} : efficiency to tag at least one tight jet in a $t\bar{t}$ event (includes the scale factor)

Acceptance (II)

- $t\bar{t}$ events from a PYTHIA Monte Carlo sample with $M_t = 178 \text{ GeV}/c^2$

Quantity	CEM	CMUP	CMX
Single tag, JP < 1% (SF = 0.82 ± 0.07)			
Acc. No Tag	$3.67 \pm 0.02 \pm 0.22$	$1.92 \pm 0.01 \pm 0.12$	$0.751 \pm 0.008 \pm 0.046$
Tag Eff.	$54.7 \pm 0.2 \pm 3.6$	$54.1 \pm 0.3 \pm 3.5$	$55.2 \pm 0.5 \pm 3.6$
Average Tag Eff.	$54.5 \pm 0.2 \pm 3.6$		
Acc. with Tag	$2.00 \pm 0.01 \pm 0.18$	$1.04 \pm 0.01 \pm 0.09$	$0.41 \pm 0.01 \pm 0.04$
$\epsilon_{t\bar{t}} \int L dt (\text{pb}^{-1})$	$6.38 \pm 0.04 \pm 0.68$	$3.30 \pm 0.03 \pm 0.36$	$1.32 \pm 0.02 \pm 0.14$

Backgrounds

- W + heavy flavor jets
- W + light jets (mistags)
- Non- W
- Electroweak processes

Backgrounds: W + Heavy Flavor Jets

- Events with a real W in association with quarks or gluons

- Estimated using W + heavy flavor MC

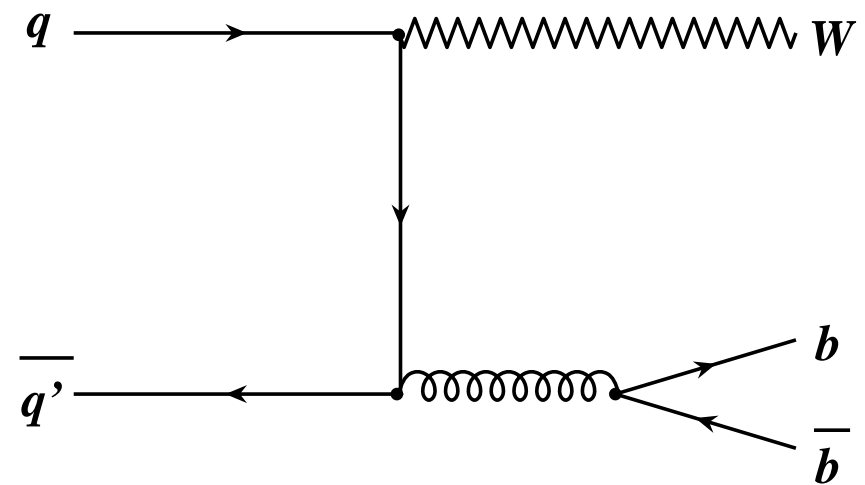
- Extract the HF fractions and the b-tag efficiencies from $\frac{W+HF}{W+Jets}$ MC

- Normalized to W+jets pretag data

- Contribution to the pretag sample: $N_{HF}^{pretag} = F_{HF} \times N_{obs}^{pretag}$

- Contribution to the tagged sample: $N_{HF}^{tag} = N_{HF}^{pretag} \times \epsilon_{btag}$

- 12.3% of the lepton + jets tagged sample

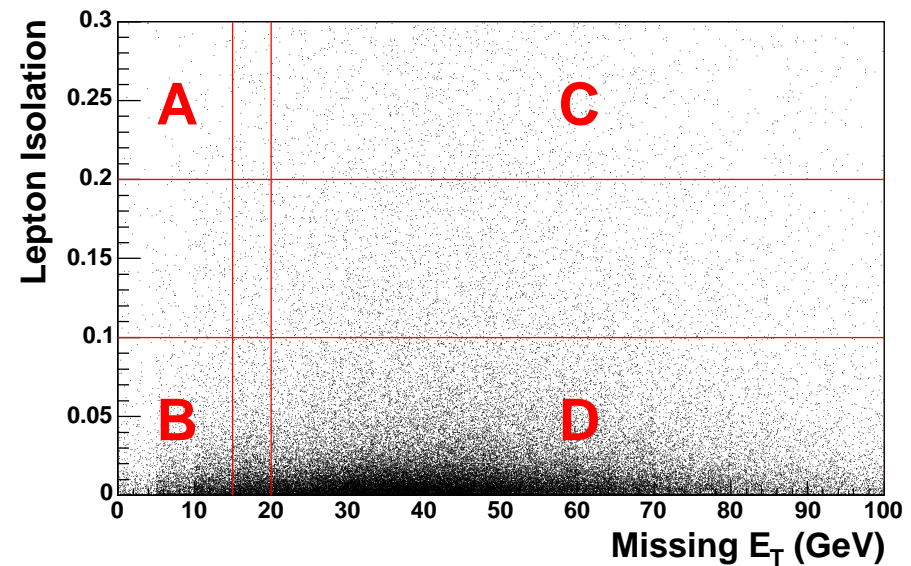
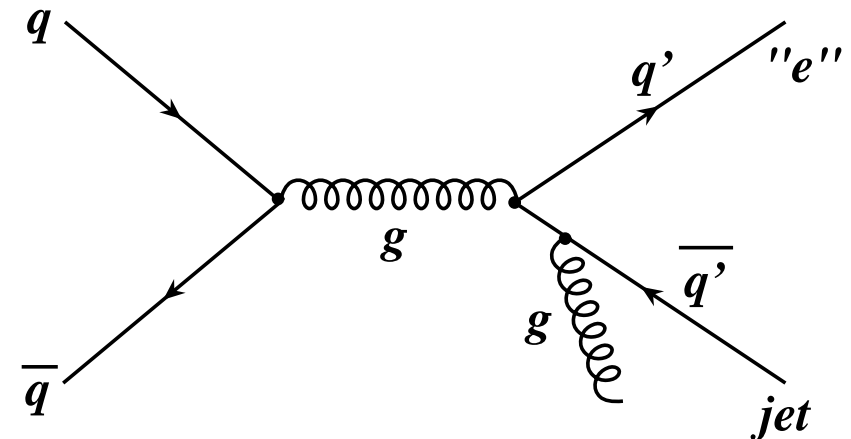


Backgrounds: Mistags

- Jets from light partons or gluons that are tagged
- Negative tags in data have large uncertainty
- Predicted, from data, by the negative tag rate matrix
 - ◇ Count events in the pretag sample
 - ◇ Weight by the probability of having one mistagged jet
 - ◇ Correct by the mistag asymmetry factor
- Accounts for 12.8% of the observed number of events

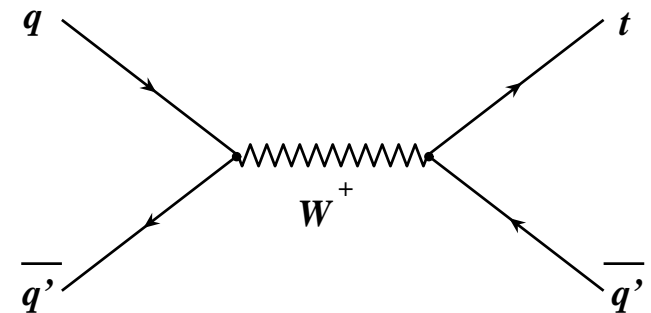
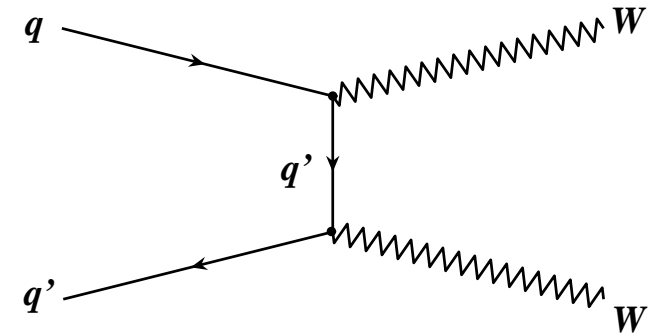
Backgrounds: non- W

- Events for which the lepton+ \cancel{E}_T signature is not due to the decay of a W
- QCD jet production where a jet fakes a lepton and the \cancel{E}_T is due to a bad measurement of the jet energies
- Minimized with the cut in $M_T^W > 20$ GeV
- Instrumental background not modelled by MC so derived from a control region in data
 - ◊ Assumes that the lepton isolation and the \cancel{E}_T of the event are uncorrelated for QCD processes $\Rightarrow \frac{N_B}{N_A} = \frac{N_D}{N_C}$
 - ◊ Not optimum method. Make 3 different estimations and assign a 50% uncertainty
- 1.2% of the tagged sample



Backgrounds: Electroweak Processes

- Dibosons: One boson decays leptonically and the other hadronically producing a b tag
- $Z \rightarrow \tau\tau$: one τ fakes the W signature and the other one is tagged
- Single top: W (from the top) decays leptonically
- Predicted from MC using the theoretical cross sections (2.5%)

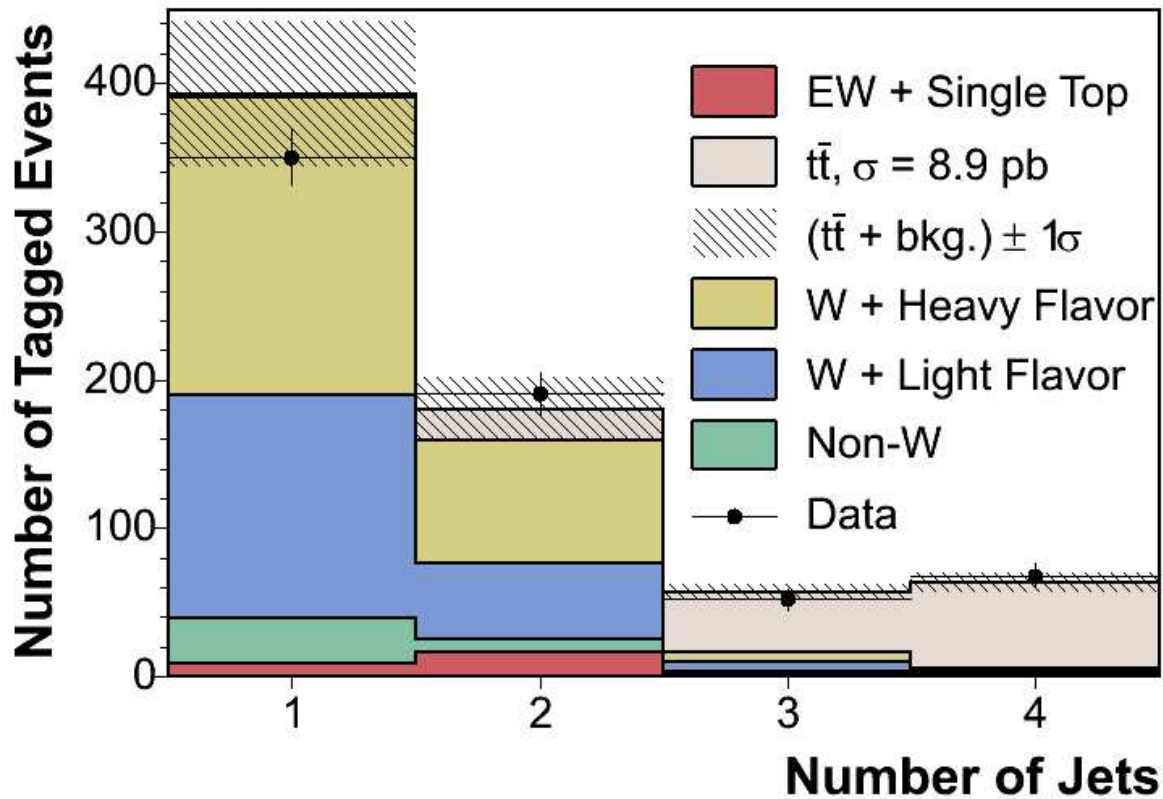


Process	Cross Section (pb)
WW	13.25 ± 0.25
WZ	3.96 ± 0.06
ZZ	1.58 ± 0.02
Single Top $W - g$ (t-channel)	1.98 ± 0.08
Single Top W^* (s-channel)	0.88 ± 0.05
$Z \rightarrow \tau^+ \tau^-$	254.3 ± 5.4

Background Summary, $P_J < 1\%$

Jet Multiplicity	1 jet	2 jets	3 jets	≥ 4 jets
Pretag Data	29339	4442	300	166
Electroweak	9.3 ± 1.1	16.6 ± 1.8	2.3 ± 0.3	0.71 ± 0.09
$Wb\bar{b}$	83 ± 23	47 ± 13	4.3 ± 1.2	1.1 ± 0.3
$Wc\bar{c}$	31 ± 9	17.3 ± 5.2	1.6 ± 0.5	0.4 ± 0.1
Wc	86 ± 21	19.0 ± 4.9	1.0 ± 0.3	0.21 ± 0.06
Mistag	149 ± 17	51 ± 6	6.1 ± 0.7	2.2 ± 0.3
Non- W	31 ± 16	8.6 ± 4.6	0.9 ± 0.6	0.5 ± 0.5
Total Background	389 ± 49	159 ± 22	16.3 ± 2.0	5.1 ± 0.7
$t\bar{t}$ (8.9 pb)	2.5 ± 0.5	20.6 ± 2.4	40.4 ± 4.5	58.1 ± 6.2
Data	350	191	52	68

Results for $P_J < 1\%$



$\sigma_{t\bar{t}}$ (pb)	Single Tag
$P_J < 1\%$	8.9 ± 1.0 (stat) $^{+1.1}_{-1.0}$ (syst)

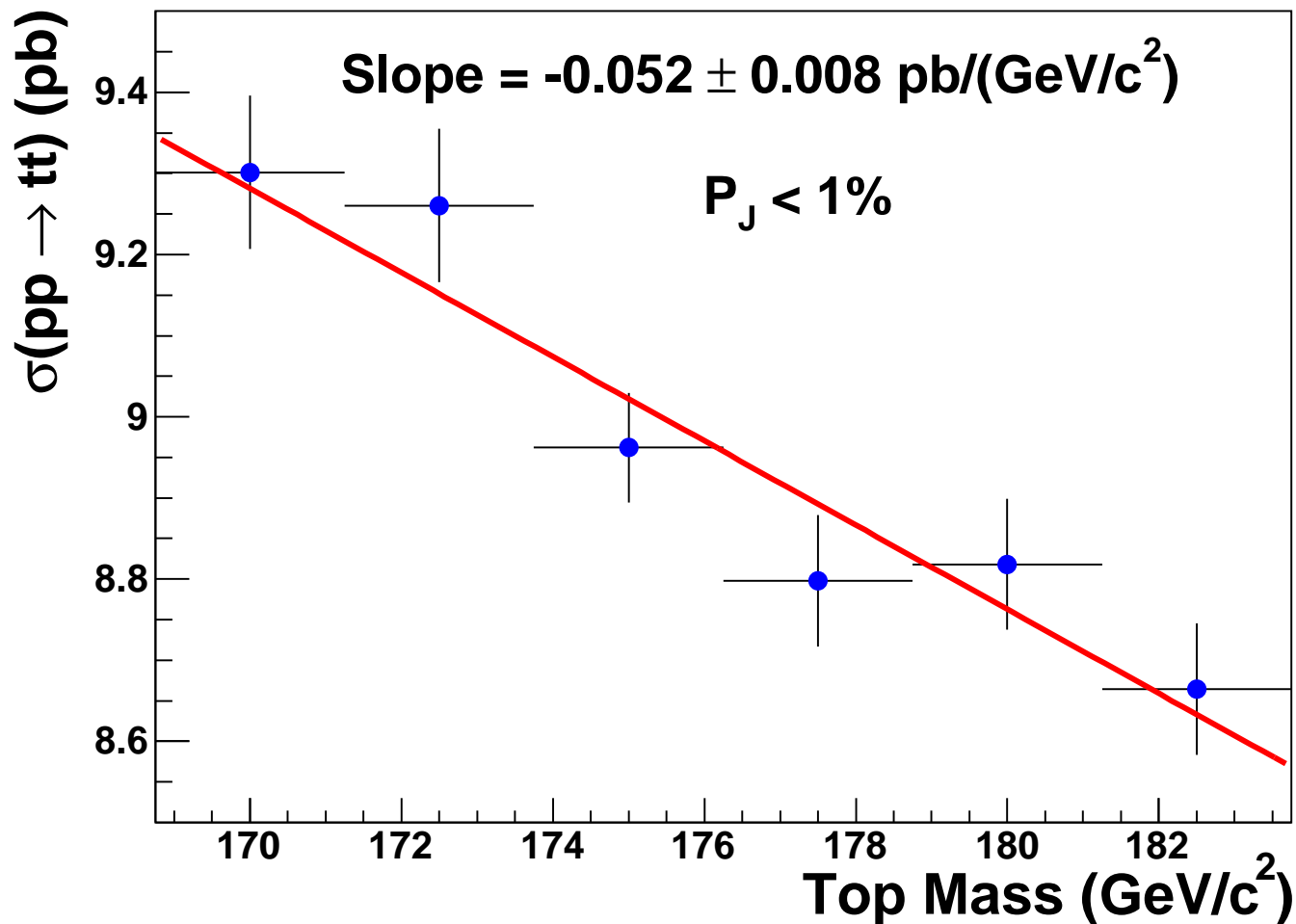
Systematic Uncertainties ($P_J < 1\%$)

- Already systematically limited
- Largest uncertainties due to the tagging SF, jet energy scale and luminosity
- For future measurements, focus on reducing systematics
 - ◇ Tagging SF
 - ◇ Jet energy scale

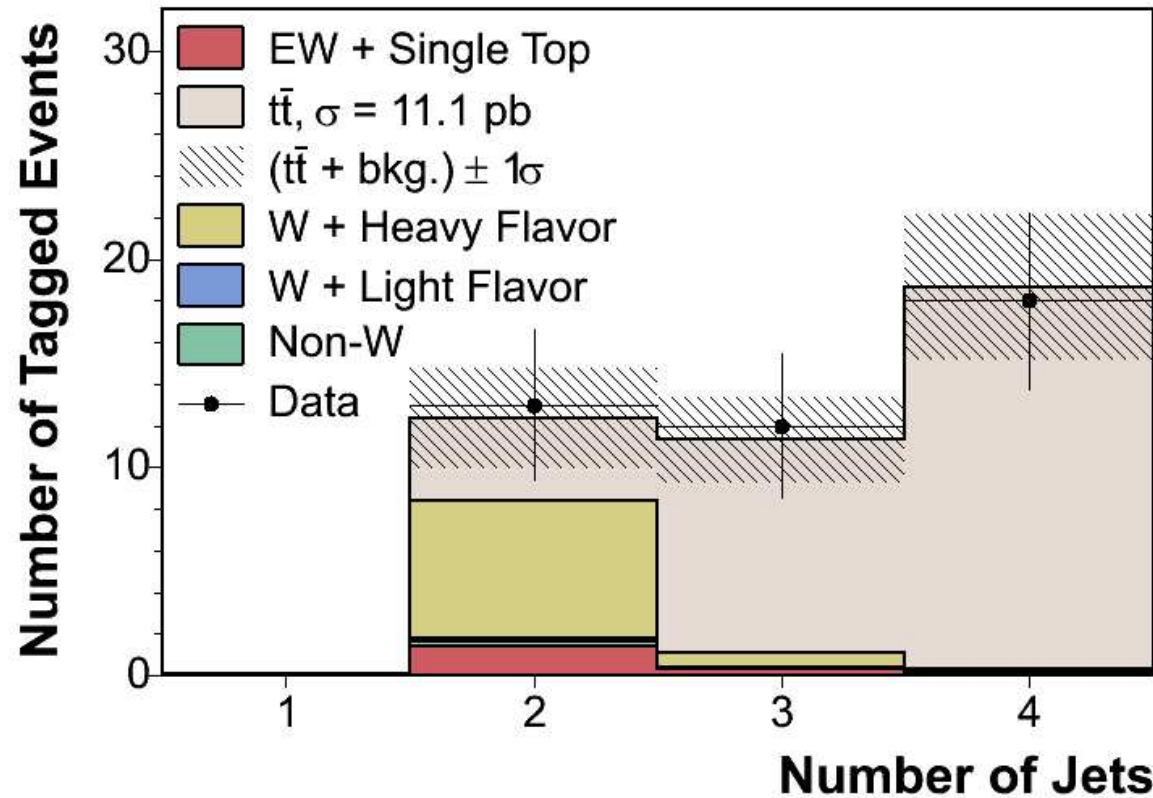
Source	Fractional Uncert. (%)	Contribution to $\sigma_{t\bar{t}}$ (%)
Central Electron ID	1.6	+0.99/-0.97
Central Muon ID	1.9	+0.61/-0.61
CMX Muon ID	1.8	+0.22/-0.22
PDF	2	+2.1/-2.0
Jet Energy Scale	4.2	+4.5/-4.2
ISR/FSR	1.3	+1.4/-1.3
MC Modeling	1.6	+1.7/-1.6
Z Vertex	2.0	+2.1/-2.1
Tagging SF (b's/c's)	8.6/12.9	+8.2/-7.2
Non- W Prediction	50	0.71
W +HF Prediction	30	2.6
Cross Sections Bkg.	1.8	0.056
Luminosity	5.9	+6.5/-5.7
Total		+12.5/-11.3

$\sigma_{t\bar{t}}$ dependence with M_t

- Reevaluate signal acceptance using HERWIG Monte Carlo samples with different values of M_t

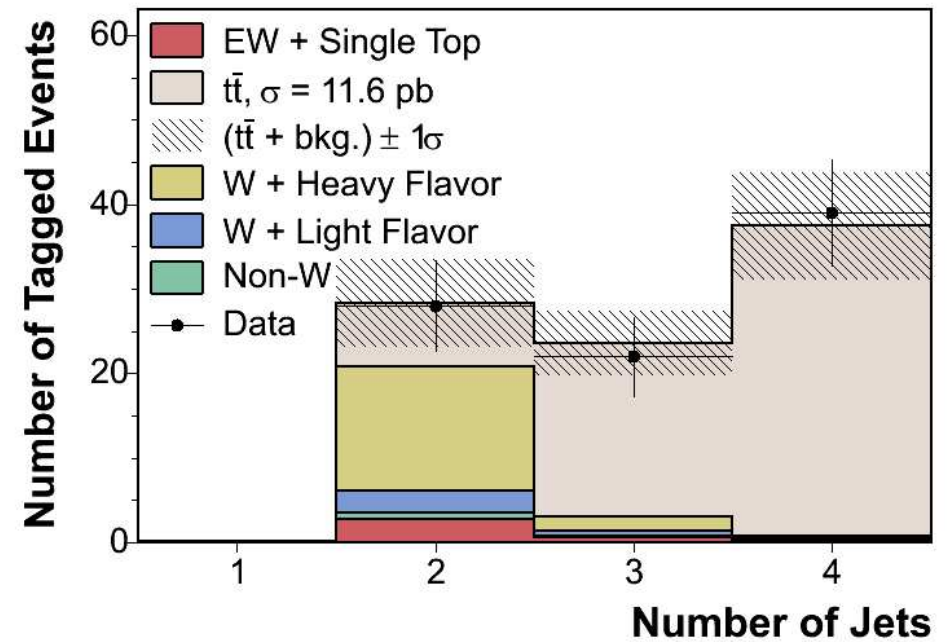
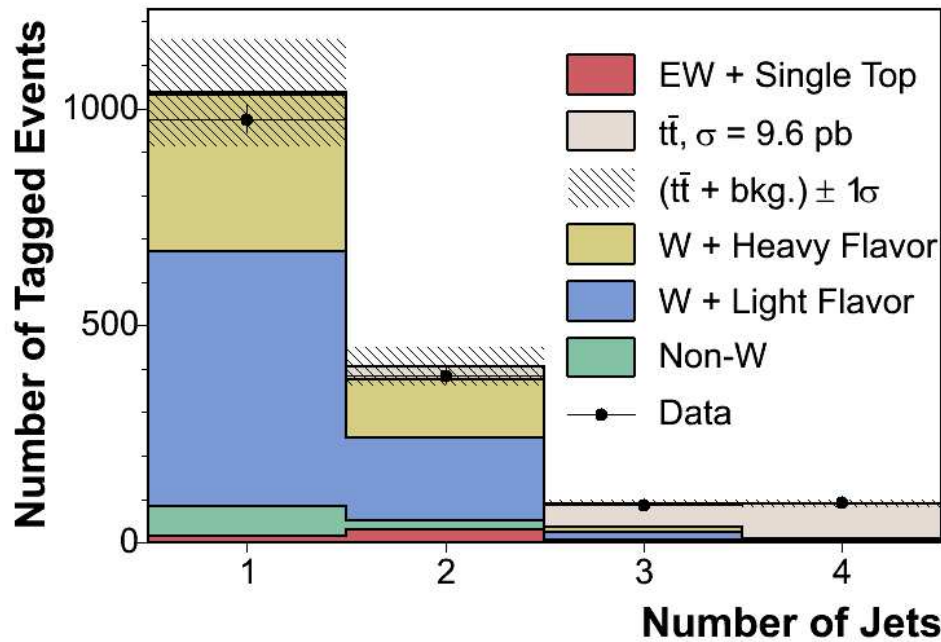


Cross Check (I): Double tag $P_J < 1\%$



$\sigma_{t\bar{t}}$ (pb)	Single Tag	Double Tag
$P_J < 1\%$	8.9 ± 1.0 (stat) $^{+1.1}_{-1.0}$ (syst)	$11.1^{+2.3}_{-1.9}$ (stat) $^{+2.5}_{-1.9}$ (syst)

Cross Check (II): $P_J < 5\%$



$\sigma_{t\bar{t}}$ (pb)	Single Tag	Double Tag
$P_J < 1\%$	8.9 ± 1.0 (stat) $^{+1.1}_{-1.0}$ (syst)	$11.1^{+2.3}_{-1.9}$ (stat) $^{+2.5}_{-1.9}$ (syst)
$P_J < 5\%$	$9.6^{+1.0}_{-0.9}$ (stat) $^{+1.2}_{-1.1}$ (syst)	$11.6^{+1.7}_{-1.5}$ (stat) $^{+2.4}_{-1.8}$ (syst)

Single vs Double Tag Cross Section

- Measurements are statistically compatible but $\sigma_{2t}/\sigma_{1t} \simeq 1.2...$
- We did 10,000 pseudoexperiments varying the total double tag background according to a Gaussian with a width equal to its uncertainty
- Add the background to the expected signal assuming σ_{1t} and vary the total number of events according to a Poisson distribution
- Count number of times the result is greater than σ_{2t} : $\text{Prob}(\sigma_{meas} > \sigma_{2t} \mid \sigma_{1t})$

	$SF - 1 \sigma$	SF	$SF + 1 \sigma$
$P_J < 1\%$	4.5%	13.2%	30%

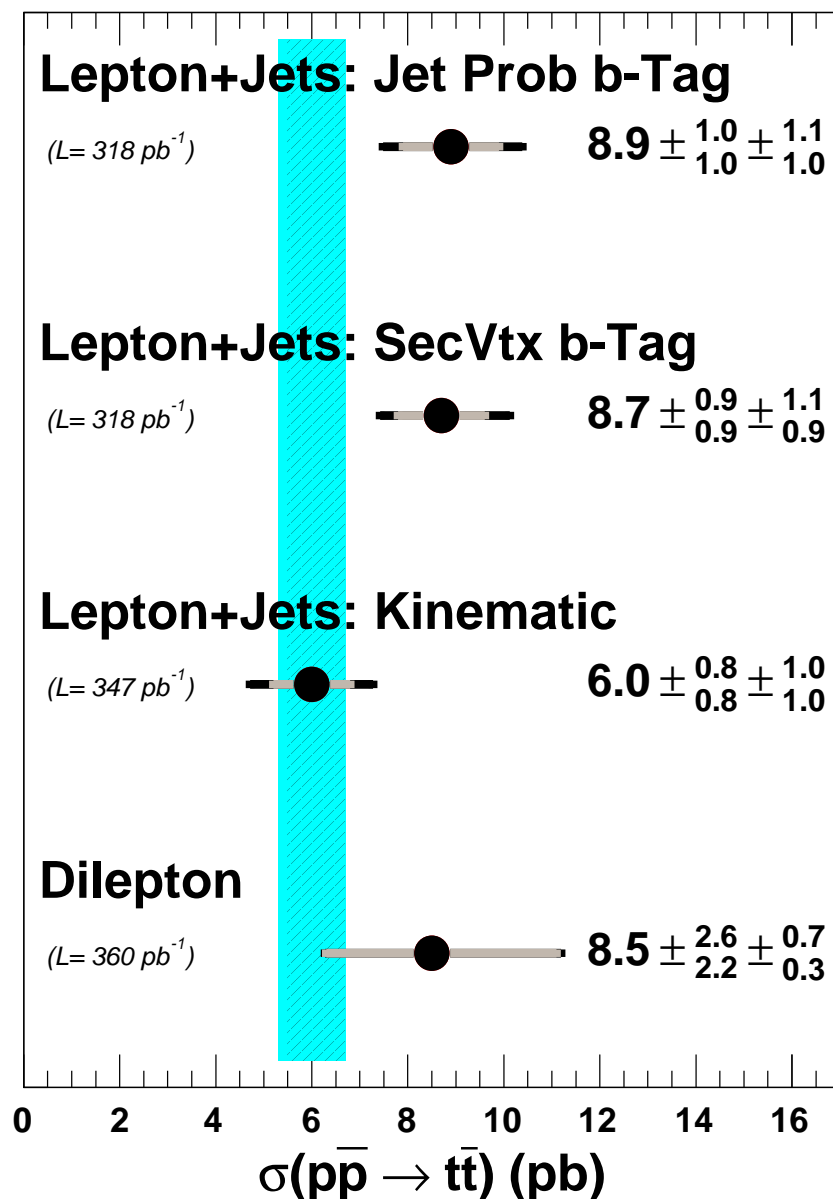
P_J	# tags	$SF - 1 \sigma$	SF	$SF + 1 \sigma$
1%	≥ 1	$9.8^{+1.1}_{-1.0}(\text{stat.})^{+1.3}_{-1.1}(\text{syst.})$	$8.9^{+1.0}_{-1.0}(\text{stat.})^{+1.1}_{-1.0}(\text{syst.})$	$8.3^{+1.0}_{-0.9}(\text{stat.})^{+1.0}_{-0.9}(\text{syst.})$
1%	≥ 2	$13.3^{+2.8}_{-2.3}(\text{stat.})^{+3.3}_{-2.4}(\text{syst.})$	$11.1^{+2.3}_{-1.9}(\text{stat.})^{+2.5}_{-1.9}(\text{syst.})$	$9.4^{+2.0}_{-1.7}(\text{stat.})^{+2.0}_{-1.4}(\text{syst.})$

Cross Check (III): Electrons and Muons samples

- We measured the cross section separately for each lepton type

	Total	Electrons	Muons
$P_J < 1\%$	$8.9^{+1.0}_{-1.0}(\text{stat.})^{+1.1}_{-1.0}(\text{syst.})$	$8.6^{+1.4}_{-1.2}(\text{stat.})^{+1.1}_{-1.0}(\text{syst.})$	$9.4^{+1.7}_{-1.4}(\text{stat.})^{+1.2}_{-1.0}(\text{syst.})$
$P_J < 5\%$	$9.6^{+1.0}_{-0.9}(\text{stat.})^{+1.2}_{-1.1}(\text{syst.})$	$9.4^{+1.3}_{-1.2}(\text{stat.})^{+1.2}_{-1.1}(\text{syst.})$	$9.9^{+1.6}_{-1.4}(\text{stat.})^{+1.2}_{-1.1}(\text{syst.})$

Consistency with other results



Summary

- We have developed the Jet Probability tagging algorithm for Run II
 - ◇ New parameterization of S_{d_0} including silicon information
 - ◇ Continuous variable based on the track impact parameter information
- Measured the efficiency using an electron data sample rich in HF
 - ◇ Used a double tag method to enhance the HF content
 - ◇ $54.5 \pm 3.6\%$ efficiency for $t\bar{t}$ events
- Built a mistag matrix using jet inclusive data sample
 - ◇ Validated using different samples
 - ◇ $1.22 \pm 0.08\%$ mistag rate
- Measured the $t\bar{t}$ production cross section in the Lepton+Jets sample
 - ◇ Check the consistency of the result
 - ◇ Value consistent with other measurements (and also with the theory). Total uncertainty of 17%
- Documented in several CDF internal notes
- Published in Phys. Rev. D. 74, 072006 and Phys. Rev. Lett. 97, 082004
- Shown at international conferences (APS 06, Lake Louise 06, DPF 06)

BACK-UP SLIDES

Scale Factor Dependence with the Jet E_T

- Used two different samples with high energy jets (jet20 and jet50)
- Cannot calculate the SF since we do not know the content of HF
- ... but variations on HF fractions are small for a large range of $E_T \Rightarrow$ we can estimate the E_T dependence of the SF from the E_T dependence of the ratio of positive tag excess between data and MC
- We combined the slope obtained with the 3 samples
- Slope is consistent with a flat dependence \Rightarrow SF is valid at any E_T

Sample	$P_J < 1\%$	$P_J < 5\%$
Inclusive Electron	-0.0082 ± 0.0037	-0.0081 ± 0.0044
Jet 20	-0.0008 ± 0.0019	-0.0028 ± 0.0024
Jet 50	0.0005 ± 0.0008	0.0005 ± 0.0009
Weighted Average	-0.00002 ± 0.00070	-0.00020 ± 0.00072

Tag Rate Matrix Definition

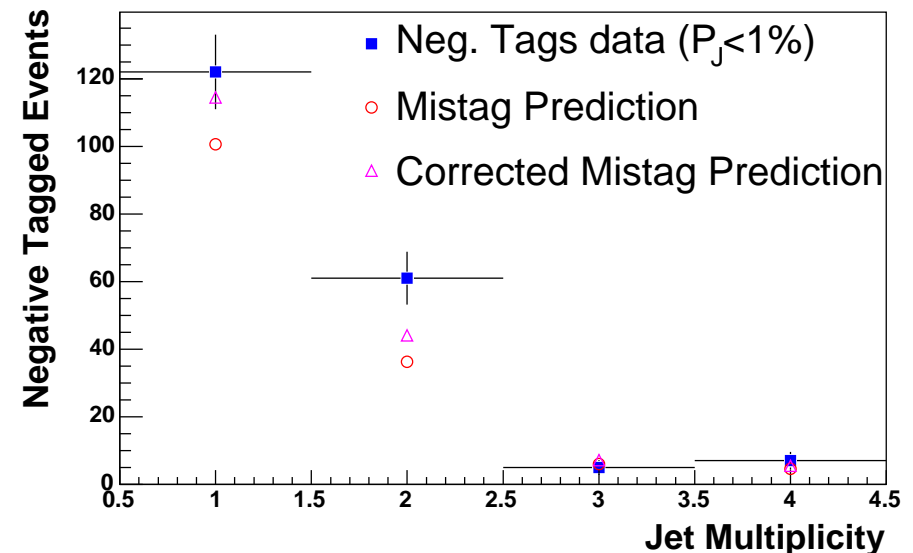
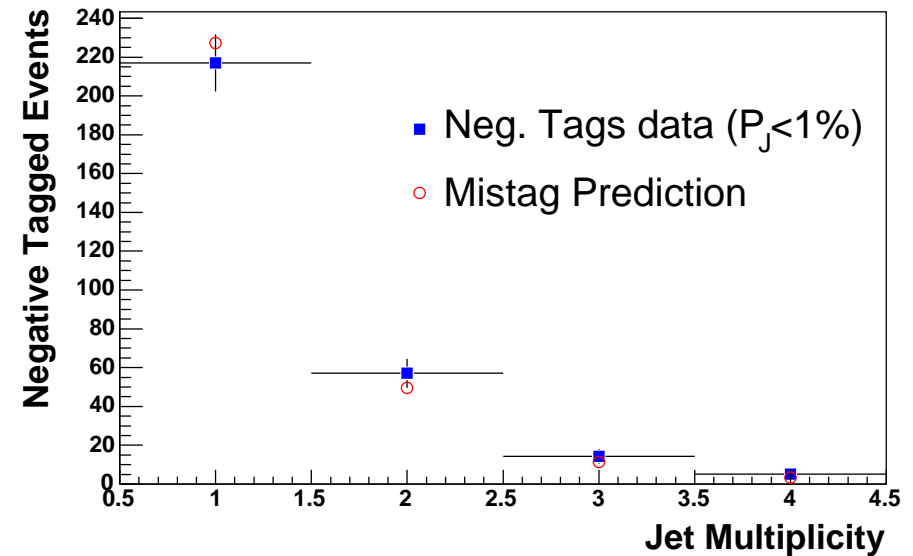
Bin	E_T (GeV)	Trk. Mult.	$\sum E_T^{\text{jets}}$ (GeV)	$ \eta $	$ Z_{\text{vtx}} $ (cm)	ϕ
1	[0,20)	2	[0,80)	[0,1.0)	[0,10)	$[\frac{-\pi}{12}, \frac{\pi}{12})$
2	[20,35)	3	[80,140)	≥ 1.0	[10,20)	$[\frac{\pi}{12}, \frac{3\pi}{12})$
3	[35,50)	4,5	[140,220)		[20,40)	$[\frac{3\pi}{12}, \frac{5\pi}{12})$
4	[50,65)	6,7	≥ 220		[40,50)	$[\frac{5\pi}{12}, \frac{7\pi}{12})$
5	[65,80)	8,9			[50,60)	$[\frac{7\pi}{12}, \frac{9\pi}{12})$
6	[80,100)	10-13			≥ 60	$[\frac{9\pi}{12}, \frac{11\pi}{12})$
7	[100,120)	≥ 14				$[\frac{11\pi}{12}, \frac{13\pi}{12})$
8	[120,150)					$[\frac{13\pi}{12}, \frac{15\pi}{12})$
9	[150,180)					$[\frac{15\pi}{12}, \frac{17\pi}{12})$
10	≥ 180					$[\frac{17\pi}{12}, \frac{19\pi}{12})$
11						$[\frac{19\pi}{12}, \frac{21\pi}{12})$
12						$[\frac{21\pi}{12}, \frac{23\pi}{12})$

Jet Probability at CDF

- Tagger has been used by other different analysis (top mass, b physics, exotics)
- Right now, measuring the efficiencies and mistag rate using 1.2 fb^{-1} of data
 - ◇ Using a new (and complementary) method for the scale factor
 - ◇ New parameterization of the mistag rate matrix
- Usefull to provide information in other tagging strategies
 - ◇ Combined tagger
 - ◇ Neural network tagger: the jet probability variable, P_J , is going to be introduced as an input variable with a high weight

Backgrounds: Mistags (II)

- We apply the mistag prediction to a subsample of the lepton+jets data with $\cancel{E}_T < 20$ GeV and find good agreement
- But if we use the pretag lepton+jets sample there is a discrepancy
- ... due to higher HF fraction in the sample with higher value of \cancel{E}_T with respect to the inclusive jet sample
- If we correct using the HF fractions the agreement is better



Background Summary, $P_J < 5\%$

Jet Multiplicity	1 jet	2 jets	3 jets	≥ 4 jets
Pretag Data	29339	4442	300	166
Electroweak	16.3 ± 1.8	28.8 ± 3.0	4.0 ± 0.4	1.4 ± 0.1
$Wb\bar{b}$	111 ± 31	60 ± 17	5.2 ± 1.4	1.1 ± 0.3
$Wc\bar{c}$	68 ± 20	36 ± 11	3.2 ± 1.0	0.76 ± 0.24
Wc	184 ± 45	40 ± 10	2.2 ± 0.6	0.5 ± 0.13
Mistag	585 ± 92	191 ± 30	19.6 ± 3.1	6.1 ± 1.0
Non- W	69 ± 35	21 ± 11	1.3 ± 0.9	0.8 ± 0.7
Total Background	1033 ± 125	377 ± 46	35.5 ± 4.2	10.6 ± 1.4
$t\bar{t}$ (9.6 pb)	3.6 ± 0.6	28.4 ± 3.1	55.1 ± 5.7	78.6 ± 7.8
Data	975	385	87	93

Background Summary, Double tag

Jet Multiplicity	2 jets	3 jets	≥ 4 jets
Pretag Data	4442	300	166
$P_J < 1\%$			
MC Derived	1.4 ± 0.3	0.33 ± 0.06	0.10 ± 0.02
$Wb\bar{b}$	6.1 ± 1.9	0.57 ± 0.19	0.10 ± 0.03
$Wc\bar{c}$	0.38 ± 0.17	0.09 ± 0.04	0.013 ± 0.008
Wc	0.12 ± 0.08	0.02 ± 0.02	0.003 ± 0.003
Mistag	0.21 ± 0.05	0.06 ± 0.01	0.019 ± 0.004
Non- W	0.19 ± 0.12	0.03 ± 0.02	0.05 ± 0.03
Total Background	8.4 ± 2.2	1.1 ± 0.3	0.28 ± 0.06
$t\bar{t}$ (11.1 pb)	3.9 ± 0.9	10.2 ± 2.0	18.4 ± 3.4
Data	13	12	18
$P_J < 5\%$			
MC Derived	2.83 ± 0.51	0.70 ± 0.12	0.25 ± 0.05
$Wb\bar{b}$	11.4 ± 3.6	1.1 ± 0.3	0.16 ± 0.05
$Wc\bar{c}$	2.3 ± 0.9	0.38 ± 0.15	0.06 ± 0.03
Wc	0.97 ± 0.37	0.16 ± 0.07	0.03 ± 0.01
Mistag	2.7 ± 0.8	0.65 ± 0.20	0.15 ± 0.05
Non- W	0.63 ± 0.34	0.09 ± 0.05	0.14 ± 0.09
Total Background	20.9 ± 5.0	3.1 ± 0.6	0.80 ± 0.15
$t\bar{t}$ (11.6 pb)	7.5 ± 1.5	20.5 ± 3.7	36.6 ± 6.1
Data	28	22	39